

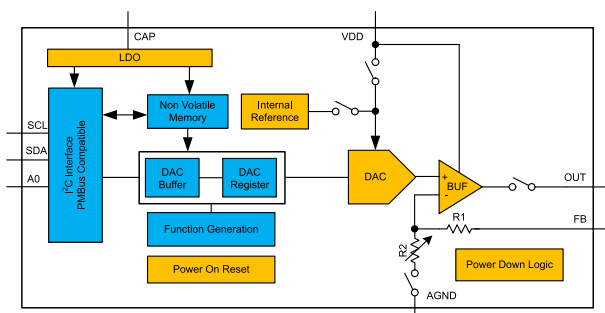
# DACx3401-Q1 具有非易失性存储器和兼容 PMBus™ 的 I<sup>2</sup>C 接口且采用微型 2 × 2 WSON 封装的汽车类 10 位和 8 位电压输出智能 DAC

## 1 特性

- 符合面向汽车应用的 AEC-Q100 标准：
  - 温度等级 1：-40°C 至 +125°C，T<sub>A</sub>
- 1 LSB INL 和 DNL (10 位和 8 位)
- 宽工作电压范围：
  - 电源：1.8V 至 5.5V
- 兼容 PMBus™ 的 I<sup>2</sup>C 接口
  - 标准模式、快速模式和快速+ 模式
  - 由 A0 引脚配置的四个从器件地址选项
  - 1.62V V<sub>IH</sub> (V<sub>DD</sub> = 5.5V)
- 用户可编程的非易失性存储器 (NVM、EEPROM)
  - 保存和撤销所有寄存器设置
- 可编程波形生成：方形、斜坡和锯齿状
- 使用三角波形和 FB 引脚的脉宽调制 (PWM) 输出
- 数字压摆率控制
- 内部基准
- 超低功耗：在 1.8V 时为 0.2 mA
- 灵活启动：高阻抗或 10K-GND
- 微型封装：8 引脚 WSON (2mm × 2mm)

## 2 应用

- 汽车 USB 充电
- 前灯
- 后灯



功能方框图

## 3 说明

10 位 DAC53401-Q1 和 8 位 DAC43401-Q1 (DACx3401-Q1) 是具有引脚兼容性的汽车类缓冲电压输出智能数模转换器 (DAC) 系列产品。这些器件功耗极低且均可采用微型 8 引脚 WSON 封装。凭借这组特性以及微型封装和低功耗，DACx3401-Q1 非常适合以下应用：LED 和通用偏置点生成、电源控制和 PWM 信号生成。

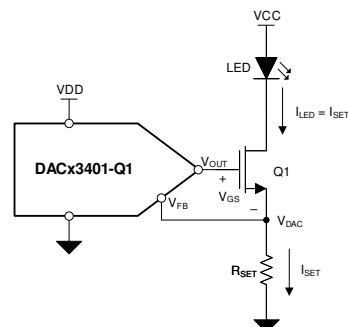
这些器件具有非易失性存储器 (NVM)、一个内部基准和一个兼容 PMBus 的 I<sup>2</sup>C 接口。DACx3401-Q1 在内部基准或电源基准下运行，提供 1.8V 至 5.5V 的满量程输出。该器件通过 I<sup>2</sup>C 接口通信。这些器件支持 I<sup>2</sup>C 标准模式、快速模式和快速+ 模式。

DACx3401-Q1 是智能 DAC 器件，因为它们具有高级集成特性。这些智能 DAC 具有强制检测输出、PWM 输出和 NVM 功能，无需使用软件即可实现系统性能和控制功能。

### 器件信息

| 器件型号 <sup>(1)</sup> | 封装       | 封装尺寸 (标称值)      |
|---------------------|----------|-----------------|
| DAC53401-Q1         | WSON (8) | 2.00mm × 2.00mm |
| DAC43401-Q1         |          |                 |

(1) 如需了解所有可用封装，请参阅数据表末尾的封装选项附录。



使用 DACx3401-Q1 的 LED 偏置



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## 4 Revision History

| DATE         | REVISION | NOTES            |
|--------------|----------|------------------|
| October 2020 | *        | Initial release. |

## 5 Device Comparison Table

| DEVICE      | RESOLUTION |
|-------------|------------|
| DAC53401-Q1 | 10-bit     |
| DAC43401-Q1 | 8-bit      |

## 6 Pin Configuration and Functions

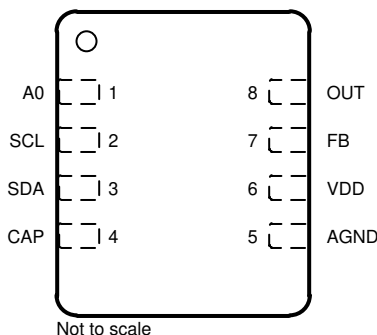


图 6-1. DSG Package, 8-Pin WSON, Top View

表 6-1. Pin Functions

| PIN  |     | TYPE         | DESCRIPTION                                                                                                                                                    |
|------|-----|--------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME | NO. |              |                                                                                                                                                                |
| A0   | 1   | Input        | Four-state address input                                                                                                                                       |
| AGND | 5   | Ground       | Ground reference point for all circuitry on the device                                                                                                         |
| CAP  | 4   | Input        | External capacitor for the internal LDO. Connect a capacitor (0.5 $\mu$ F to 15 $\mu$ F) between CAP and AGND.                                                 |
| FB   | 7   | Input        | Voltage feedback pin                                                                                                                                           |
| OUT  | 8   | Output       | Analog output voltage from DAC                                                                                                                                 |
| SCL  | 2   | Input        | Serial interface clock. This pin must be connected to the supply voltage with an external pullup resistor.                                                     |
| SDA  | 3   | Input/output | Data are clocked into or out of the input register. This pin is a bidirectional, and must be connected to the supply voltage with an external pullup resistor. |
| VDD  | 6   | Power        | Analog supply voltage: 1.8 V to 5.5 V                                                                                                                          |

## 7 Specifications

### 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                  |                                                     | MIN   | MAX                   | UNIT |
|------------------|-----------------------------------------------------|-------|-----------------------|------|
| V <sub>DD</sub>  | Supply voltage, V <sub>DD</sub> to A <sub>GND</sub> | - 0.3 | 6                     | V    |
|                  | Digital input(s) to A <sub>GND</sub>                | - 0.3 | V <sub>DD</sub> + 0.3 | V    |
|                  | CAP to A <sub>GND</sub>                             | - 0.3 | 1.65                  | V    |
|                  | V <sub>FB</sub> to A <sub>GND</sub>                 | - 0.3 | V <sub>DD</sub> + 0.3 | V    |
|                  | V <sub>OUT</sub> to A <sub>GND</sub>                | - 0.3 | V <sub>DD</sub> + 0.3 | V    |
|                  | Current into any pin                                | - 10  | 10                    | mA   |
| T <sub>J</sub>   | Junction temperature                                | - 40  | 150                   | °C   |
| T <sub>stg</sub> | Storage temperature                                 | - 65  | 150                   | °C   |

- (1) Stresses beyond those listed under *Absolute Maximum Rating* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Condition*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 7.2 ESD Ratings

|                    |                         |                                                                                           | VALUE | UNIT |
|--------------------|-------------------------|-------------------------------------------------------------------------------------------|-------|------|
| V <sub>(ESD)</sub> | Electrostatic discharge | Human body model (HBM), per AEC Q100-002 <sup>(1)</sup><br>HBM ESD classification level 2 | ±2000 | V    |
|                    |                         | Charged device model (CDM), per AEC Q100-011<br>CDM ESD classification level C5           | ±750  |      |

- (1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

### 7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|                 |                                                             | MIN  | NOM | MAX | UNIT |
|-----------------|-------------------------------------------------------------|------|-----|-----|------|
| V <sub>DD</sub> | Positive supply voltage to ground (A <sub>GND</sub> )       | 1.71 |     | 5.5 | V    |
| V <sub>IH</sub> | Digital input high voltage, 1.7 V < V <sub>DD</sub> ≤ 5.5 V | 1.62 |     |     | V    |
| V <sub>IL</sub> | Digital input low voltage                                   |      |     | 0.4 | V    |
| T <sub>A</sub>  | Ambient temperature                                         | - 40 |     | 125 | °C   |

### 7.4 Thermal Information

| THERMAL METRIC <sup>(1)</sup> |                                              | DACx3401-Q1 | UNIT |
|-------------------------------|----------------------------------------------|-------------|------|
|                               |                                              | DSG (WSON)  |      |
|                               |                                              | 8 PINS      |      |
| R <sub>θJA</sub>              | Junction-to-ambient thermal resistance       | 49          | °C/W |
| R <sub>θJC(top)</sub>         | Junction-to-case (top) thermal resistance    | 50          | °C/W |
| R <sub>θJB</sub>              | Junction-to-board thermal resistance         | 24.1        | °C/W |
| Ψ <sub>JT</sub>               | Junction-to-top characterization parameter   | 1.1         | °C/W |
| Ψ <sub>JB</sub>               | Junction-to-board characterization parameter | 24.1        | °C/W |
| R <sub>θJC(bot)</sub>         | Junction-to-case (bottom) thermal resistance | 8.7         | °C/W |

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics application report](#).

## 7.5 Electrical Characteristics

all minimum/maximum specifications at  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  and typical specifications at  $T_A = 25^{\circ}\text{C}$ ,  $1.8\text{ V} \leq V_{DD} \leq 5.5\text{ V}$ , DAC reference tied to  $V_{DD}$ , gain = 1x, DAC output pin (OUT) loaded with resistive load ( $R_L = 5\text{ k}\Omega$  to AGND) and capacitive load ( $C_L = 200\text{ pF}$  to AGND), and digital inputs at  $V_{DD}$  or AGND (unless otherwise noted)

| PARAMETER                     |                                                     | TEST CONDITIONS                                                                                                                                                                                         | MIN   | TYP          | MAX | UNIT                           |
|-------------------------------|-----------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------|--------------|-----|--------------------------------|
| <b>STATIC PERFORMANCE</b>     |                                                     |                                                                                                                                                                                                         |       |              |     |                                |
|                               | Resolution                                          | DAC53401-Q1                                                                                                                                                                                             | 10    |              |     | Bits                           |
|                               |                                                     | DAC43401-Q1                                                                                                                                                                                             | 8     |              |     |                                |
| INL                           | Relative accuracy <sup>(1)</sup>                    |                                                                                                                                                                                                         | - 1   |              | 1   | LSB                            |
| DNL                           | Differential nonlinearity <sup>(1)</sup>            |                                                                                                                                                                                                         | - 1   |              | 1   | LSB                            |
|                               | Zero code error                                     | Code 0d into DAC                                                                                                                                                                                        |       | 6            | 12  | mV                             |
|                               |                                                     | Internal $V_{REF}$ , gain = 4x, $V_{DD} = 5.5\text{ V}$                                                                                                                                                 |       | 6            | 15  |                                |
|                               | Zero code error temperature coefficient             |                                                                                                                                                                                                         |       | $\pm 10$     |     | $\mu\text{V}/^{\circ}\text{C}$ |
|                               | Offset error <sup>(4)</sup>                         |                                                                                                                                                                                                         | - 0.6 | 0.25         | 0.6 | %FSR                           |
|                               | Offset error temperature coefficient <sup>(4)</sup> |                                                                                                                                                                                                         |       | $\pm 0.0003$ |     | %FSR/ $^{\circ}\text{C}$       |
|                               | Gain error <sup>(4)</sup>                           |                                                                                                                                                                                                         | - 0.5 | 0.25         | 0.5 | %FSR                           |
|                               | Gain error temperature coefficient <sup>(4)</sup>   |                                                                                                                                                                                                         |       | $\pm 0.0008$ |     | %FSR/ $^{\circ}\text{C}$       |
|                               | Full scale error                                    | $1.8\text{ V} \leq V_{DD} < 2.7\text{ V}$ , code 1023d into DAC, no headroom                                                                                                                            | - 1   | 0.5          | 1   | %FSR                           |
|                               |                                                     | $2.7\text{ V} \leq V_{DD} \leq 5.5\text{ V}$ , code 1023d into DAC, no headroom                                                                                                                         | - 0.5 | 0.25         | 0.5 |                                |
|                               | Full scale error temperature coefficient            |                                                                                                                                                                                                         |       | $\pm 0.0008$ |     | %FSR/ $^{\circ}\text{C}$       |
| <b>OUTPUT CHARACTERISTICS</b> |                                                     |                                                                                                                                                                                                         |       |              |     |                                |
|                               | Output voltage                                      | Reference tied to $V_{DD}$                                                                                                                                                                              | 0     |              | 5.5 | V                              |
| $C_L$                         | Capacitive load <sup>(2)</sup>                      | $R_L = \text{Infinite}$ , phase margin = $30^{\circ}$                                                                                                                                                   |       |              | 1   | nF                             |
|                               |                                                     | $R_L = 5\text{ k}\Omega$ , phase margin = $30^{\circ}$                                                                                                                                                  |       |              | 2   |                                |
|                               | Load regulation                                     | DAC at midscale, $-10\text{ mA} \leq I_{OUT} \leq 10\text{ mA}$ , $V_{DD} = 5.5\text{ V}$                                                                                                               |       | 0.4          |     | mV/mA                          |
|                               | Short circuit current                               | $V_{DD} = 1.8\text{ V}$ , full-scale output shorted to $A_{GND}$ or zero-scale output shorted to $V_{DD}$                                                                                               |       | 10           |     | mA                             |
|                               |                                                     | $V_{DD} = 2.7\text{ V}$ , full-scale output shorted to $A_{GND}$ or zero-scale output shorted to $V_{DD}$                                                                                               |       | 25           |     |                                |
|                               |                                                     | $V_{DD} = 5.5\text{ V}$ , full-scale output shorted to $A_{GND}$ or zero-scale output shorted to $V_{DD}$                                                                                               |       | 50           |     |                                |
|                               | Output voltage headroom <sup>(1)</sup>              | To $V_{DD}$ (DAC output unloaded, internal reference = 1.21 V), $V_{DD} \geq 1.21 \times \text{gain} + 0.2\text{ V}$                                                                                    |       | 0.2          |     | V                              |
|                               |                                                     | To $V_{DD}$ (DAC output unloaded, reference tied to $V_{DD}$ )                                                                                                                                          |       | 0.8          |     |                                |
|                               |                                                     | To $V_{DD}$ ( $I_{LOAD} = 10\text{ mA}$ at $V_{DD} = 5.5\text{ V}$ , $I_{LOAD} = 3\text{ mA}$ at $V_{DD} = 2.7\text{ V}$ , $I_{LOAD} = 1\text{ mA}$ at $V_{DD} = 1.8\text{ V}$ ), DAC code = full scale | 10    |              |     |                                |
|                               | $V_{OUT}$ dc output impedance                       | DAC output enabled and DAC code = midscale                                                                                                                                                              |       | 0.25         |     | $\Omega$                       |
|                               |                                                     | DAC output enabled and DAC code = 4d                                                                                                                                                                    |       | 0.25         |     |                                |
|                               |                                                     | DAC output enabled and DAC code = 1016d                                                                                                                                                                 |       | 0.26         |     |                                |
| $Z_O$                         | $V_{FB}$ dc output impedance <sup>(3)</sup>         | DAC output enabled, DAC reference tied to $V_{DD}$ (gain = 1x) or internal reference (gain = 1.5x or 2x)                                                                                                | 160   | 200          | 240 | $\text{k}\Omega$               |
|                               |                                                     | DAC output enabled, internal $V_{REF}$ , gain = 3x or 4x                                                                                                                                                | 192   | 240          | 288 |                                |

## 7.5 Electrical Characteristics (continued)

all minimum/maximum specifications at  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  and typical specifications at  $T_A = 25^{\circ}\text{C}$ ,  $1.8\text{ V} \leq V_{DD} \leq 5.5\text{ V}$ , DAC reference tied to VDD, gain = 1x, DAC output pin (OUT) loaded with resistive load ( $R_L = 5\text{ k}\Omega$  to AGND) and capacitive load ( $C_L = 200\text{ pF}$  to AGND), and digital inputs at VDD or AGND (unless otherwise noted)

| PARAMETER                  |                                                         | TEST CONDITIONS                                                                                                    | MIN | TYP   | MAX | UNIT                           |
|----------------------------|---------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------|-----|-------|-----|--------------------------------|
|                            | $V_{OUT} + V_{FB}$ dc output leakage <sup>(2)</sup>     | At startup, measured when DAC output is disabled and held at $V_{DD}/2$ for $V_{DD} = 5.5\text{ V}$                |     |       | 5   | nA                             |
|                            | Power supply rejection ratio (dc)                       | Internal $V_{REF}$ , gain = 2x, DAC at midscale; $V_{DD} = 5\text{ V} \pm 10\%$                                    |     | 0.25  |     | mV/V                           |
| <b>DYNAMIC PERFORMANCE</b> |                                                         |                                                                                                                    |     |       |     |                                |
| $t_{sett}$                 | Output voltage settling time                            | 1/4 to 3/4 scale and 3/4 to 1/4 scale settling to 10%FSR, $V_{DD} = 5.5\text{ V}$                                  |     | 8     |     | $\mu\text{s}$                  |
|                            |                                                         | 1/4 to 3/4 scale and 3/4 to 1/4 scale settling to 10%FSR, $V_{DD} = 5.5\text{ V}$ , internal $V_{REF}$ , gain = 4x |     | 12    |     |                                |
|                            | Slew rate                                               | $V_{DD} = 5.5\text{ V}$                                                                                            |     | 1     |     | V/ $\mu\text{s}$               |
|                            | Power-on glitch magnitude                               | At startup (DAC output disabled), $R_L = 5\text{ k}\Omega$ , $C_L = 200\text{ pF}$                                 |     | 75    |     | mV                             |
|                            |                                                         | At startup (DAC output disabled), $R_L = 100\text{ k}\Omega$                                                       |     | 200   |     |                                |
|                            | Output enable glitch magnitude                          | DAC output disabled to enabled (DAC registers at zero scale, $R_L = 100\text{ k}\Omega$ )                          |     | 250   |     | mV                             |
| $V_n$                      | Output noise voltage (peak to peak)                     | 0.1 Hz to 10 Hz, DAC at midscale, $V_{DD} = 5.5\text{ V}$                                                          |     | 34    |     | $\mu\text{V}_{PP}$             |
|                            |                                                         | Internal $V_{REF}$ , gain = 4x, 0.1 Hz to 10 Hz, DAC at midscale, $V_{DD} = 5.5\text{ V}$                          |     | 70    |     |                                |
|                            | Output noise density                                    | Measured at 1 kHz, DAC at midscale, $V_{DD} = 5.5\text{ V}$                                                        |     | 0.2   |     | $\mu\text{V}/\sqrt{\text{Hz}}$ |
|                            |                                                         | Internal $V_{REF}$ , gain = 4x, measured at 1 kHz, DAC at midscale, $V_{DD} = 5.5\text{ V}$                        |     | 0.7   |     |                                |
|                            | Power supply rejection ratio (ac) <sup>(3)</sup>        | Internal $V_{REF}$ , gain = 4x, 200-mV 50 or 60 Hz sine wave superimposed on power supply voltage, DAC at midscale |     | -71   |     | dB                             |
|                            | Code change glitch impulse                              | $\pm 1$ LSB change around mid code (including feedthrough)                                                         |     | 10    |     | nV-s                           |
|                            | Code change glitch impulse magnitude                    | $\pm 1$ LSB change around mid code (including feedthrough)                                                         |     | 15    |     | mV                             |
| <b>VOLTAGE REFERENCE</b>   |                                                         |                                                                                                                    |     |       |     |                                |
|                            | Initial accuracy                                        | $T_A = 25^{\circ}\text{C}$                                                                                         |     | 1.212 |     | V                              |
|                            | Reference output temperature coefficient <sup>(2)</sup> |                                                                                                                    |     |       | 50  | ppm/ $^{\circ}\text{C}$        |
| <b>EEPROM</b>              |                                                         |                                                                                                                    |     |       |     |                                |
|                            | Endurance                                               | $-40^{\circ}\text{C} \leq T_A \leq +85^{\circ}\text{C}$                                                            |     | 20000 |     | Cycles                         |
|                            |                                                         | $T_A > 85^{\circ}\text{C}$                                                                                         |     | 1000  |     |                                |
|                            | Data retention <sup>(2)</sup>                           | $T_A = 25^{\circ}\text{C}$                                                                                         |     | 50    |     | Years                          |
|                            | EEPROM programming write cycle time <sup>(2)</sup>      |                                                                                                                    | 10  |       | 20  | ms                             |
| <b>DIGITAL INPUTS</b>      |                                                         |                                                                                                                    |     |       |     |                                |
|                            | Digital feedthrough                                     | DAC output static at midscale, fast mode plus, SCL toggling                                                        |     | 20    |     | nV-s                           |
|                            | Pin capacitance                                         | Per pin                                                                                                            |     | 10    |     | pF                             |

## 7.5 Electrical Characteristics (continued)

all minimum/maximum specifications at  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  and typical specifications at  $T_A = 25^{\circ}\text{C}$ ,  $1.8\text{ V} \leq V_{DD} \leq 5.5\text{ V}$ , DAC reference tied to VDD, gain = 1x, DAC output pin (OUT) loaded with resistive load ( $R_L = 5\text{ k}\Omega$  to AGND) and capacitive load ( $C_L = 200\text{ pF}$  to AGND), and digital inputs at VDD or AGND (unless otherwise noted)

| PARAMETER    |                                         | TEST CONDITIONS                                      | MIN | TYP | MAX | UNIT          |
|--------------|-----------------------------------------|------------------------------------------------------|-----|-----|-----|---------------|
| <b>POWER</b> |                                         |                                                      |     |     |     |               |
|              | Load capacitor - CAP pin <sup>(2)</sup> |                                                      | 0.5 |     | 15  | $\mu\text{F}$ |
| $I_{DD}$     | Current flowing into VDD                | Normal mode, DACs at full scale, digital pins static |     | 0.5 | 0.8 | mA            |
|              |                                         | DAC power-down, internal reference power down        |     | 80  |     | $\mu\text{A}$ |

- (1) Measured with DAC output unloaded. For external reference between end-point codes: 8d to 1016d for 10-bit resolution, 2d to 254d for 8-bit resolution. For internal reference  $V_{DD} \geq 1.21 \times \text{gain} + 0.2\text{ V}$ , between end-point codes: 8d to 1016d for 10-bit resolution, 2d to 254d for 8-bit resolution.
- (2) Specified by design and characterization, not production tested.
- (3) Specified with 200-mV headroom with respect to reference value when internal reference is used.
- (4) Measured with DAC output unloaded. For 10-bit resolution, between end-point codes: 8d to 1016d and for 8-bit resolution, between end-point codes: 2d to 254d.

## 7.6 Timing Requirements: I<sup>2</sup>C Standard Mode

all input signals are timed from VIL to 70% of  $V_{DD}$ ,  $1.8\text{ V} \leq V_{DD} \leq 5.5\text{ V}$ ,  $-40^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$ , and  $1.8\text{ V} \leq V_{\text{pull-up}} \leq V_{DD}\text{ V}$  (unless otherwise noted)

|                    |                                                 | MIN  | NOM | MAX  | UNIT          |
|--------------------|-------------------------------------------------|------|-----|------|---------------|
| $f_{\text{SCLK}}$  | SCL frequency                                   |      |     | 0.1  | MHz           |
| $t_{\text{BUF}}$   | Bus free time between stop and start conditions | 4.7  |     |      | $\mu\text{s}$ |
| $t_{\text{HDSTA}}$ | Hold time after repeated start                  | 4    |     |      | $\mu\text{s}$ |
| $t_{\text{SUSTA}}$ | Repeated start setup time                       | 4.7  |     |      | $\mu\text{s}$ |
| $t_{\text{SUSTO}}$ | Stop condition setup time                       | 4    |     |      | $\mu\text{s}$ |
| $t_{\text{HDDAT}}$ | Data hold time                                  | 0    |     |      | ns            |
| $t_{\text{SUDAT}}$ | Data setup time                                 | 250  |     |      | ns            |
| $t_{\text{LOW}}$   | SCL clock low period                            | 4700 |     |      | ns            |
| $t_{\text{HIGH}}$  | SCL clock high period                           | 4000 |     |      | ns            |
| $t_{\text{F}}$     | Clock and data fall time                        |      |     | 300  | ns            |
| $t_{\text{R}}$     | Clock and data rise time                        |      |     | 1000 | ns            |

## 7.7 Timing Requirements: I<sup>2</sup>C Fast Mode

all input signals are timed from VIL to 70% of V<sub>DD</sub>, 1.8 V ≤ V<sub>DD</sub> ≤ 5.5 V, -40°C ≤ T<sub>A</sub> ≤ +125°C, and 1.8 V ≤ V<sub>pull-up</sub> ≤ V<sub>DD</sub> V (unless otherwise noted)

|                    |                                                 | MIN  | NOM | MAX | UNIT |
|--------------------|-------------------------------------------------|------|-----|-----|------|
| f <sub>SCLK</sub>  | SCL frequency                                   |      |     | 0.4 | MHz  |
| t <sub>BUF</sub>   | Bus free time between stop and start conditions | 1.3  |     |     | μs   |
| t <sub>HDSTA</sub> | Hold time after repeated start                  | 0.6  |     |     | μs   |
| t <sub>SUSTA</sub> | Repeated start setup time                       | 0.6  |     |     | μs   |
| t <sub>SUSTO</sub> | Stop condition setup time                       | 0.6  |     |     | μs   |
| t <sub>HDDAT</sub> | Data hold time                                  | 0    |     |     | ns   |
| t <sub>SUDAT</sub> | Data setup time                                 | 100  |     |     | ns   |
| t <sub>LOW</sub>   | SCL clock low period                            | 1300 |     |     | ns   |
| t <sub>HIGH</sub>  | SCL clock high period                           | 600  |     |     | ns   |
| t <sub>F</sub>     | Clock and data fall time                        |      |     | 300 | ns   |
| t <sub>R</sub>     | Clock and data rise time                        |      |     | 300 | ns   |

## 7.8 Timing Requirements: I<sup>2</sup>C Fast Mode Plus

all input signals are timed from VIL to 70% of V<sub>DD</sub>, 1.8 V ≤ V<sub>DD</sub> ≤ 5.5 V, -40°C ≤ T<sub>A</sub> ≤ +125°C, and 1.8 V ≤ V<sub>pull-up</sub> ≤ V<sub>DD</sub> V (unless otherwise noted)

|                    |                                                 | MIN  | NOM | MAX | UNIT |
|--------------------|-------------------------------------------------|------|-----|-----|------|
| f <sub>SCLK</sub>  | SCL frequency                                   |      |     | 1   | MHz  |
| t <sub>BUF</sub>   | Bus free time between stop and start conditions | 0.5  |     |     | μs   |
| t <sub>HDSTA</sub> | Hold time after repeated start                  | 0.26 |     |     | μs   |
| t <sub>SUSTA</sub> | Repeated start setup time                       | 0.26 |     |     | μs   |
| t <sub>SUSTO</sub> | Stop condition setup time                       | 0.26 |     |     | μs   |
| t <sub>HDDAT</sub> | Data hold time                                  | 0    |     |     | ns   |
| t <sub>SUDAT</sub> | Data setup time                                 | 50   |     |     | ns   |
| t <sub>LOW</sub>   | SCL clock low period                            | 0.5  |     |     | μs   |
| t <sub>HIGH</sub>  | SCL clock high period                           | 0.26 |     |     | μs   |
| t <sub>F</sub>     | Clock and data fall time                        |      |     | 120 | ns   |
| t <sub>R</sub>     | Clock and data rise time                        |      |     | 120 | ns   |

## 7.9 Typical Characteristics: $V_{DD} = 1.8\text{ V}$ (Reference = $V_{DD}$ ) or $V_{DD} = 2\text{ V}$ (Internal Reference)

at  $T_A = 25^\circ\text{C}$ , 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)

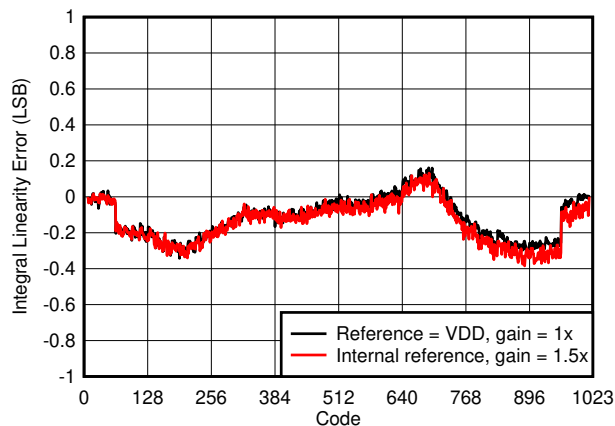


图 7-1. Integral Linearity Error vs Digital Input Code

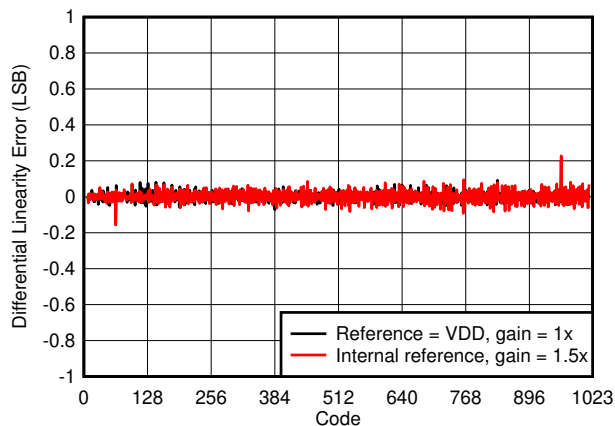


图 7-2. Differential Linearity Error vs Digital Input Code

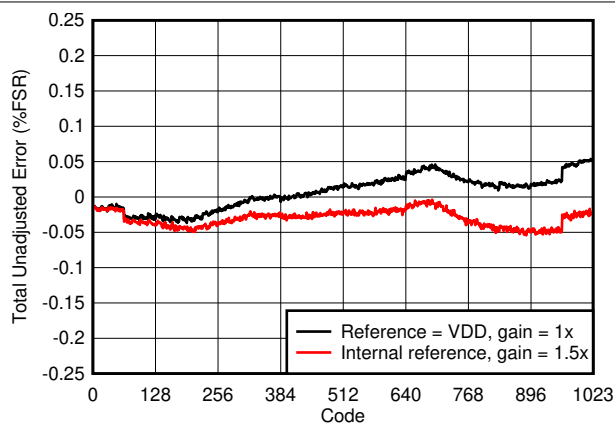


图 7-3. Total Unadjusted Error vs Digital Input Code

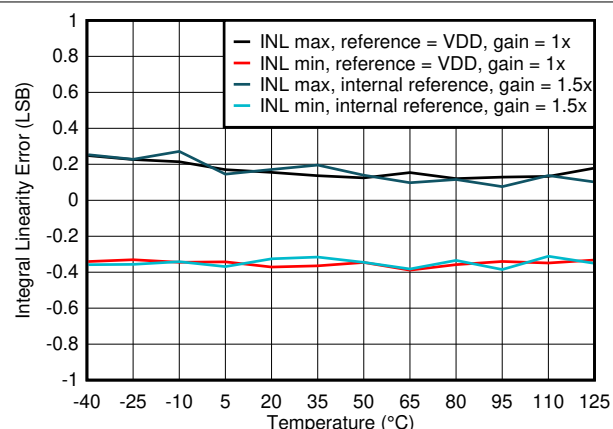


图 7-4. Integral Linearity Error vs Temperature

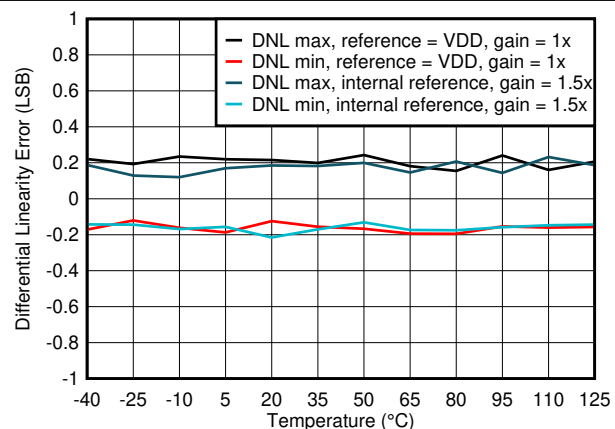


图 7-5. Differential Linearity Error vs Temperature

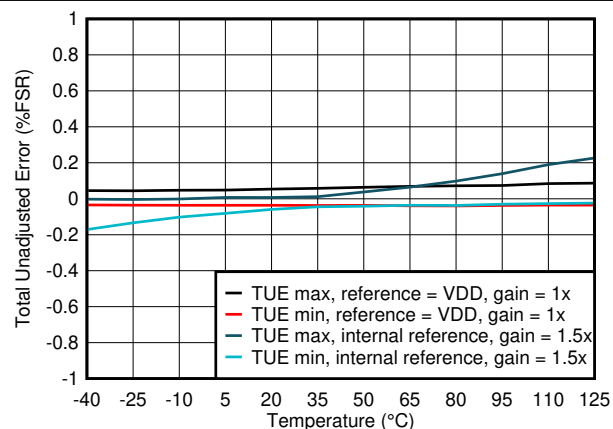
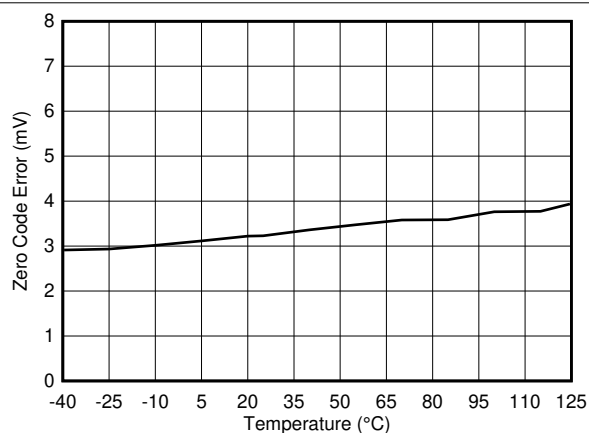


图 7-6. Total Unadjusted Error vs Temperature

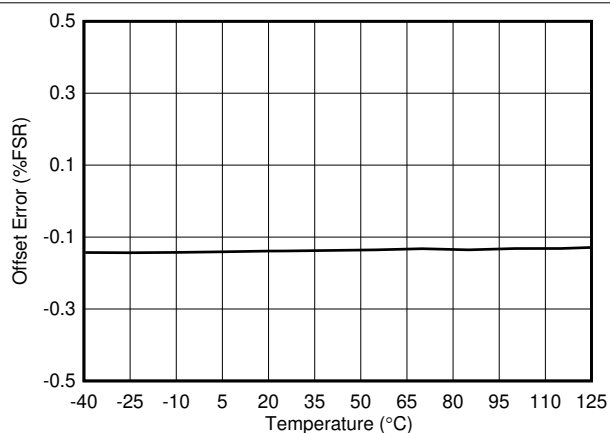
## 7.9 Typical Characteristics: $V_{DD} = 1.8\text{ V}$ (Reference = $V_{DD}$ ) or $V_{DD} = 2\text{ V}$ (Internal Reference) (continued)

at  $T_A = 25^\circ\text{C}$ , 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)



Reference =  $V_{DD}$

图 7-7. Zero Code Error vs Temperature



Reference =  $V_{DD}$

图 7-8. Offset Error vs Temperature

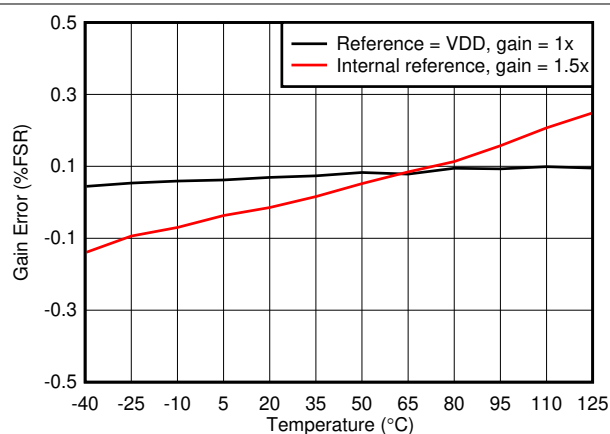


图 7-9. Gain Error vs Temperature

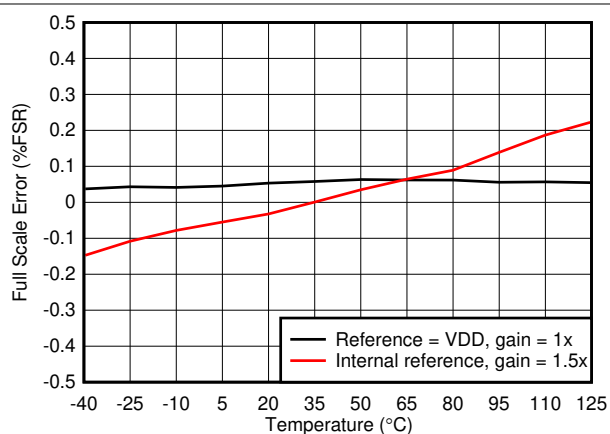


图 7-10. Full-Scale Error vs Temperature

## 7.10 Typical Characteristics: $V_{DD} = 5.5\text{ V}$ (Reference = $V_{DD}$ ) or $V_{DD} = 5\text{ V}$ (Internal Reference)

at  $T_A = 25^\circ\text{C}$ , 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)

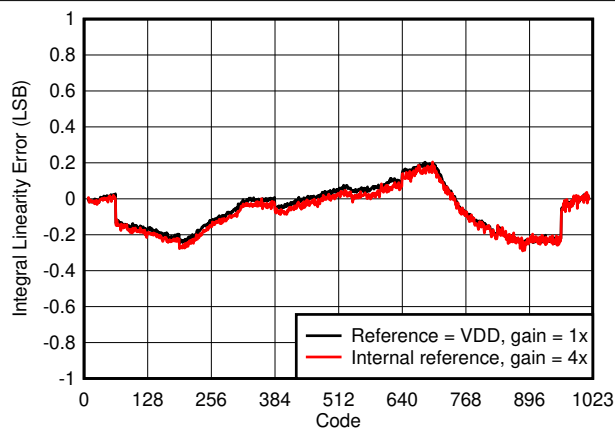


图 7-11. Integral Linearity Error vs Digital Input Code

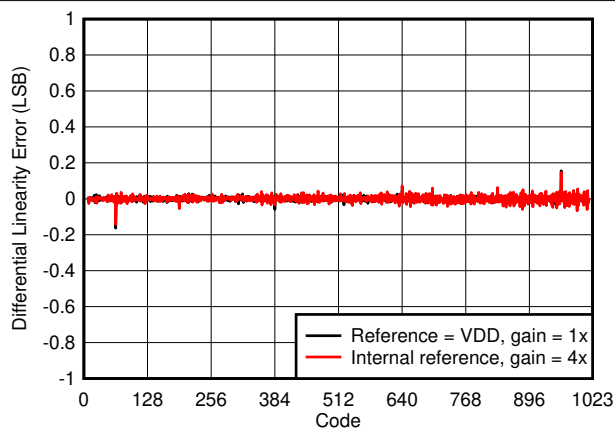


图 7-12. Differential Linearity Error vs Digital Input Code

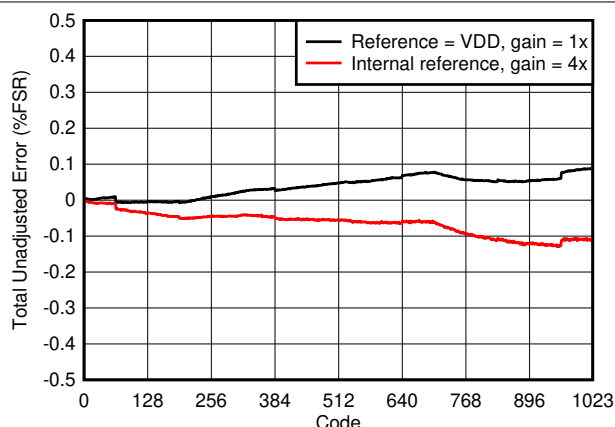


图 7-13. Total Unadjusted Error vs Digital Input Code

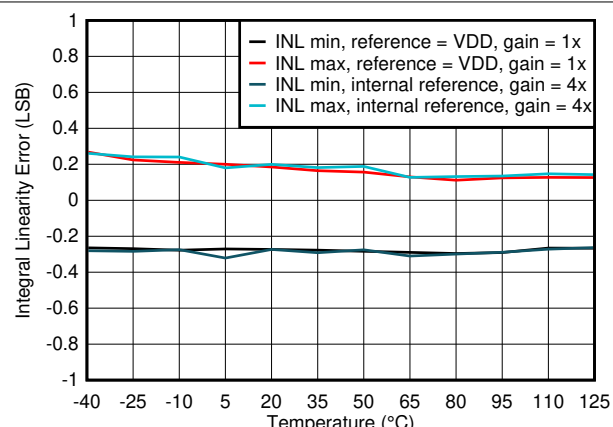


图 7-14. Integral Linearity Error vs Temperature

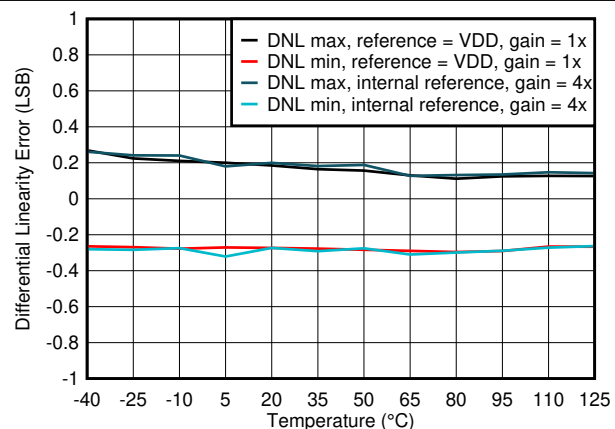


图 7-15. Differential Linearity Error vs Temperature

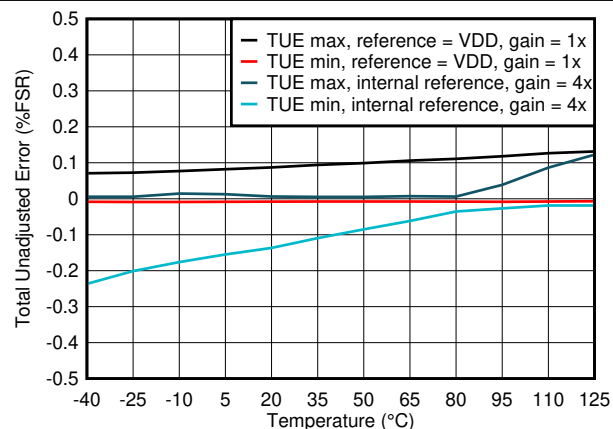
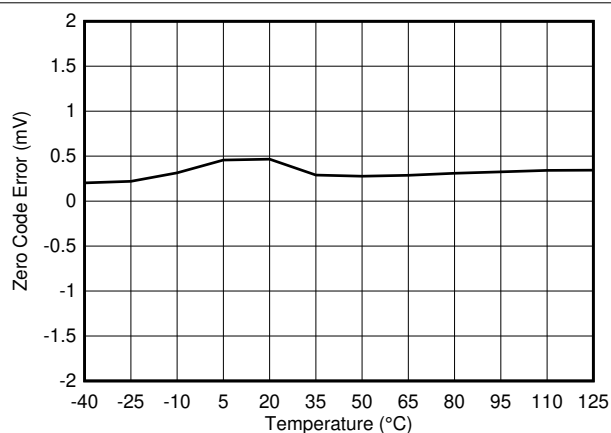


图 7-16. Total Unadjusted Error vs Temperature

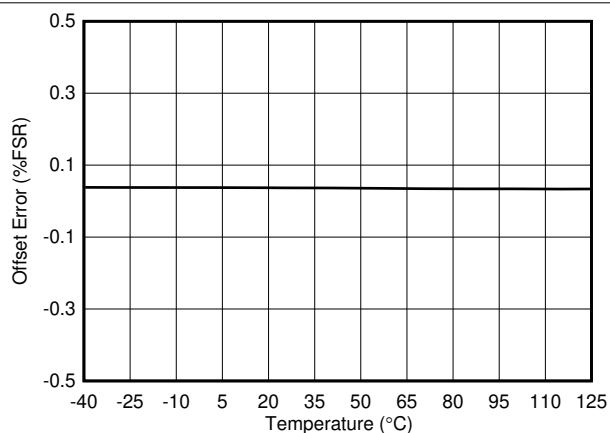
## 7.10 Typical Characteristics: $V_{DD} = 5.5\text{ V}$ (Reference = $V_{DD}$ ) or $V_{DD} = 5\text{ V}$ (Internal Reference) (continued)

at  $T_A = 25^\circ\text{C}$ , 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)



Reference =  $V_{DD}$

图 7-17. Zero Code Error vs Temperature



Reference =  $V_{DD}$

图 7-18. Offset Error vs Temperature

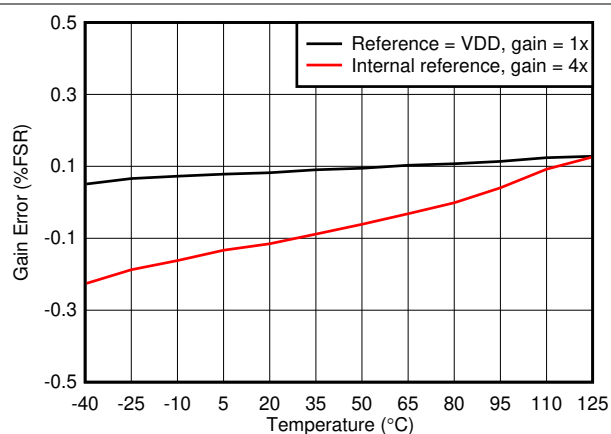


图 7-19. Gain Error vs Temperature

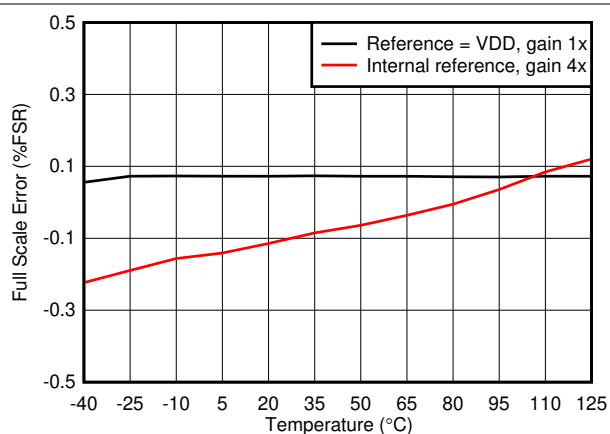
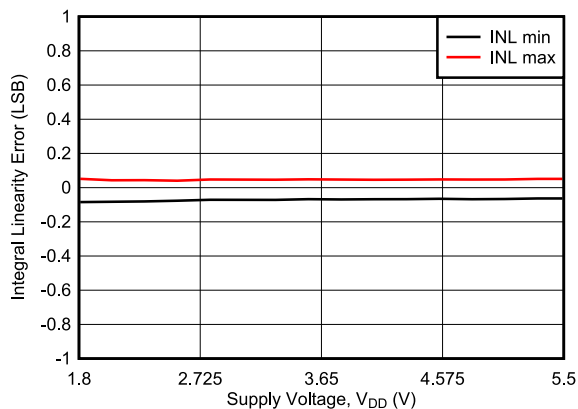


图 7-20. Full-Scale Error vs Temperature

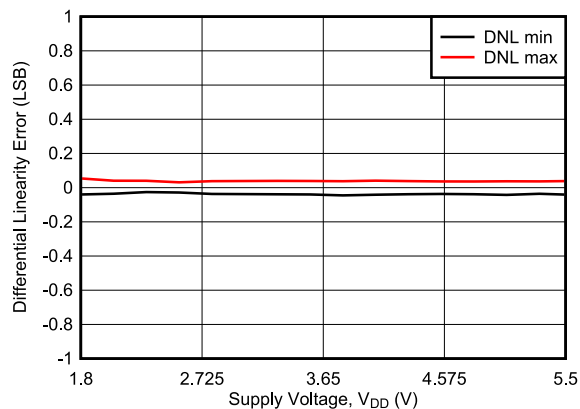
## 7.11 Typical Characteristics

at  $T_A = 25^\circ\text{C}$ , 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)



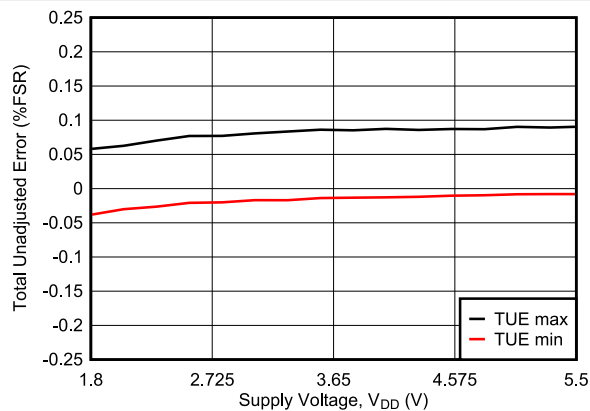
Reference =  $V_{DD}$

**图 7-21. Integral Linearity Error vs Supply Voltage**



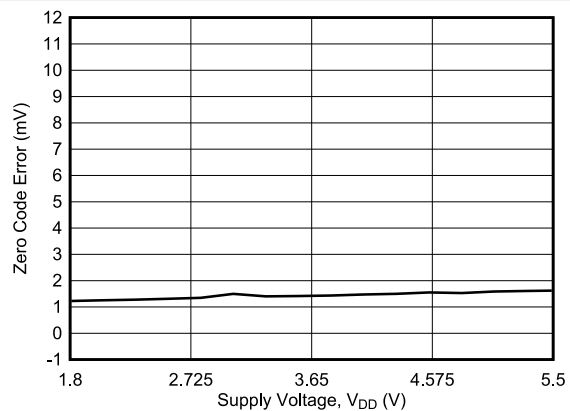
Reference =  $V_{DD}$

**图 7-22. Differential Linearity Error vs Supply Voltage**



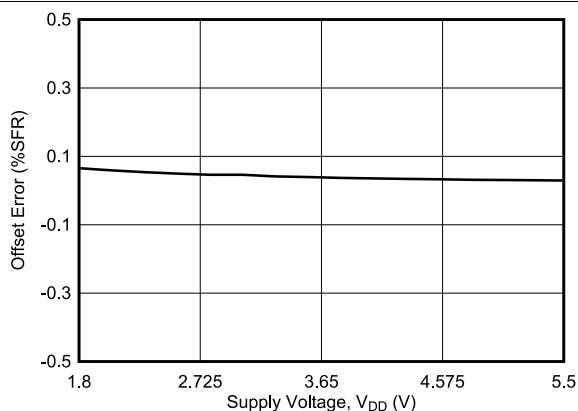
Reference =  $V_{DD}$

**图 7-23. Total Unadjusted Error vs Supply Voltage**



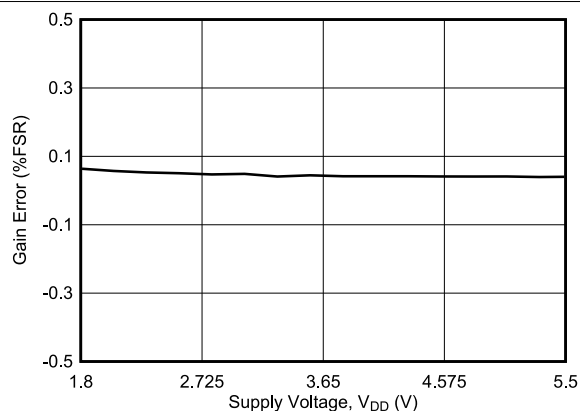
Reference =  $V_{DD}$

**图 7-24. Zero-Code Error vs Supply Voltage**



Reference =  $V_{DD}$

**图 7-25. Offset Error vs Supply Voltage**



Reference =  $V_{DD}$

**图 7-26. Gain Error vs Supply Voltage**

## 7.11 Typical Characteristics (continued)

at  $T_A = 25^\circ\text{C}$ , 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)

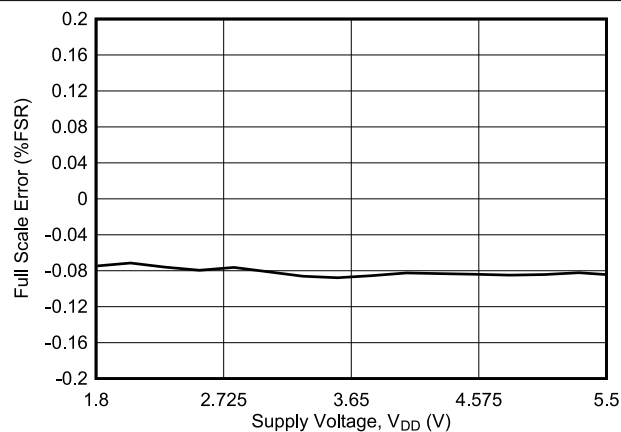


图 7-27. Full-Scale Error vs Supply Voltage

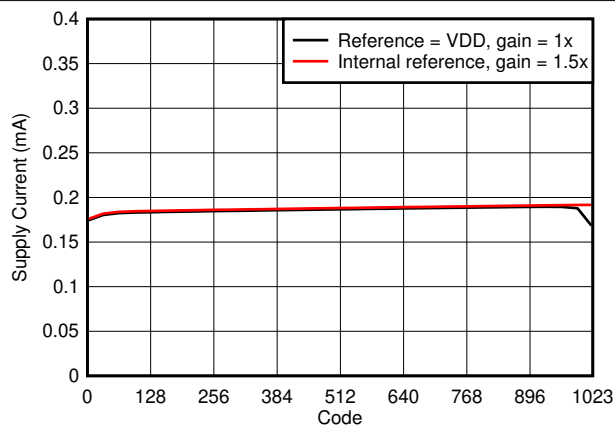


图 7-28. Supply Current vs Digital Input Code

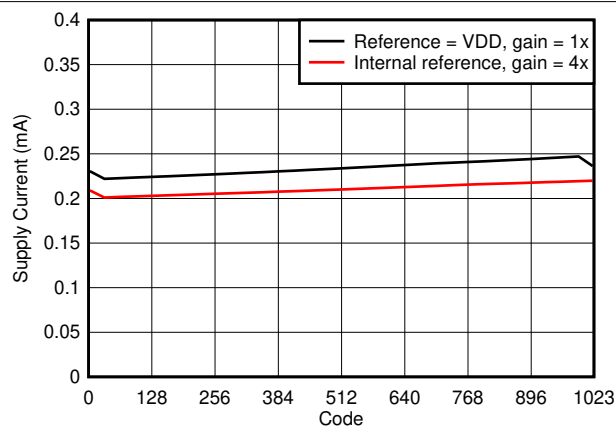


图 7-29. Supply Current vs Digital Input Code

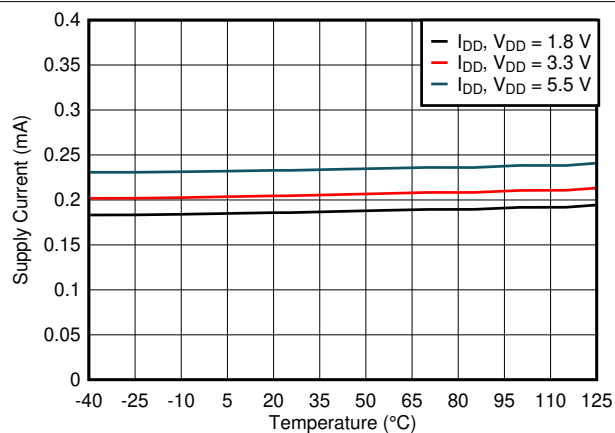


图 7-30. Supply Current vs Temperature

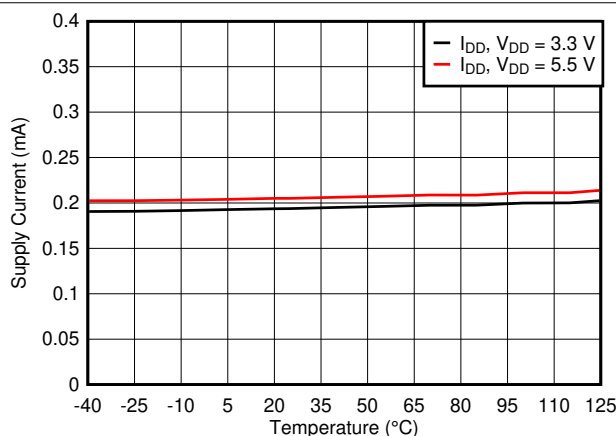


图 7-31. Supply Current vs Temperature

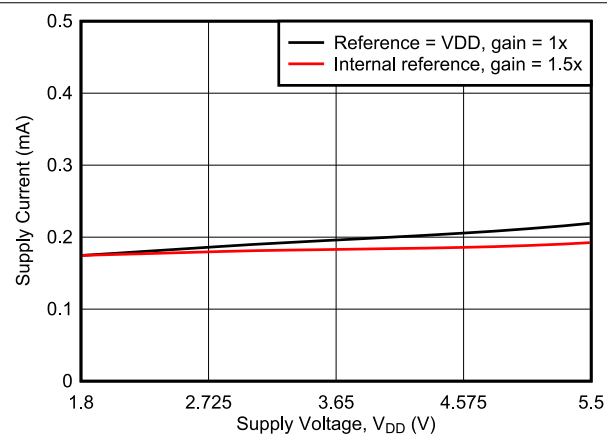
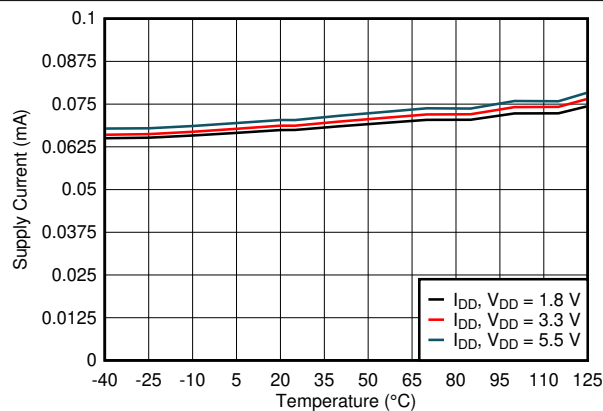


图 7-32. Supply Current vs Supply Voltage

## 7.11 Typical Characteristics (continued)

at  $T_A = 25^\circ\text{C}$ , 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)



Reference =  $V_{DD}$ , DAC powered down

图 7-33. Power-Down Current vs Temperature

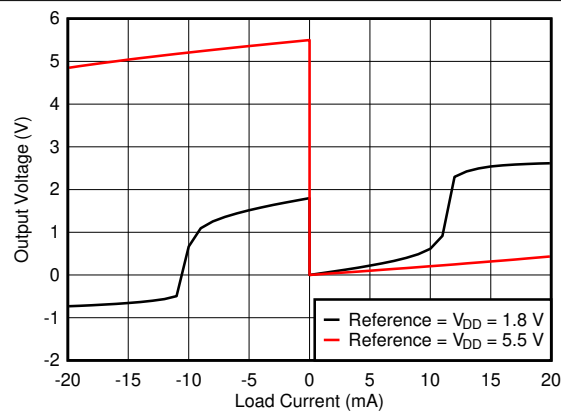
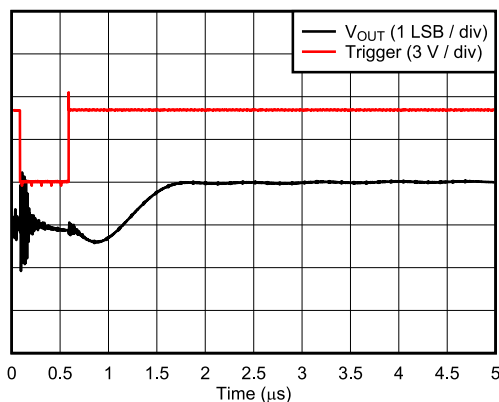
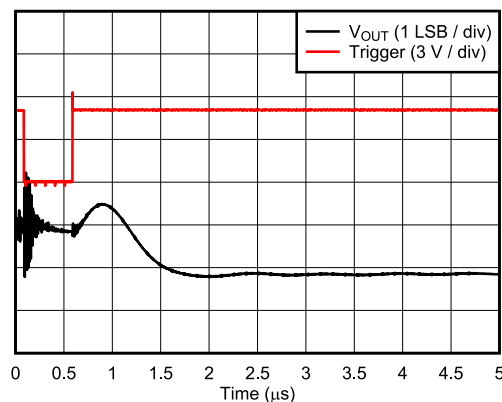


图 7-34. Source and Sink Capability



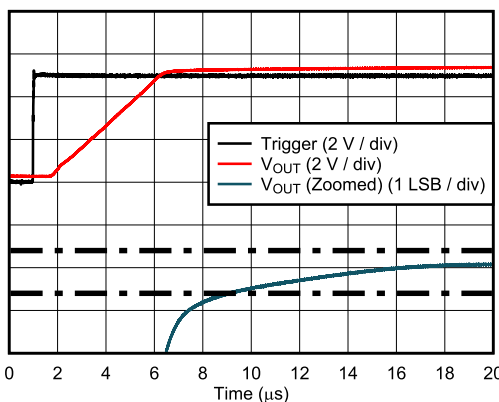
Reference =  $V_{DD} = 5.5\text{ V}$ , DAC code transition from midscale to midscale + 1 LSB, DAC load =  $5\text{ k}\Omega \parallel 200\text{ pF}$

图 7-35. Glitch Impulse, Rising Edge, 1-LSB Step



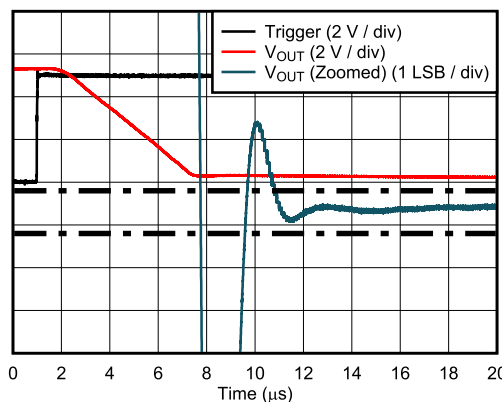
Reference =  $V_{DD} = 5.5\text{ V}$ , DAC code transition from midscale to midscale - 1 LSB, DAC load =  $5\text{ k}\Omega \parallel 200\text{ pF}$

图 7-36. Glitch Impulse, Falling Edge, 1-LSB Step



Reference =  $V_{DD} = 5.5\text{ V}$ , DAC load =  $5\text{ k}\Omega \parallel 200\text{ pF}$

图 7-37. Full-Scale Settling Time, Rising Edge

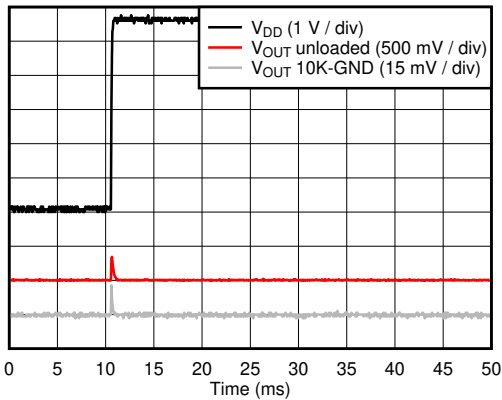


Reference =  $V_{DD} = 5.5\text{ V}$ , DAC load =  $5\text{ k}\Omega \parallel 200\text{ pF}$

图 7-38. Full-Scale Settling Time, Falling Edge

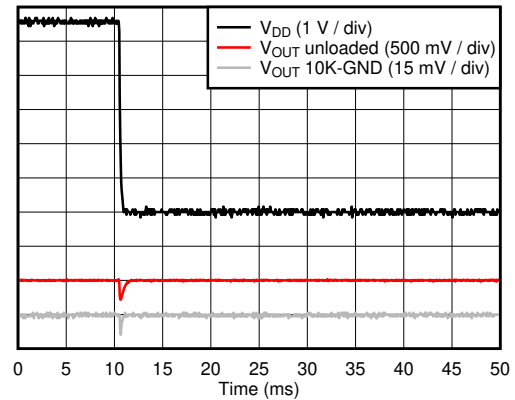
## 7.11 Typical Characteristics (continued)

at  $T_A = 25^\circ\text{C}$ , 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)



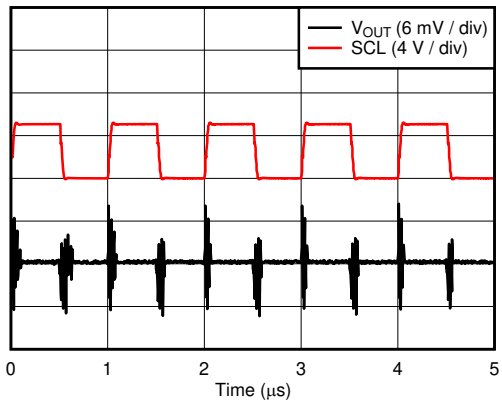
Reference =  $V_{DD} = 5.5\text{ V}$

图 7-39. Power-on Glitch



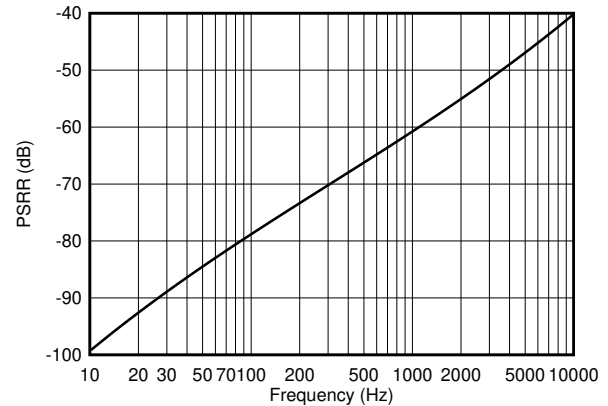
Reference =  $V_{DD} = 5.5\text{ V}$

图 7-40. Power-off Glitch



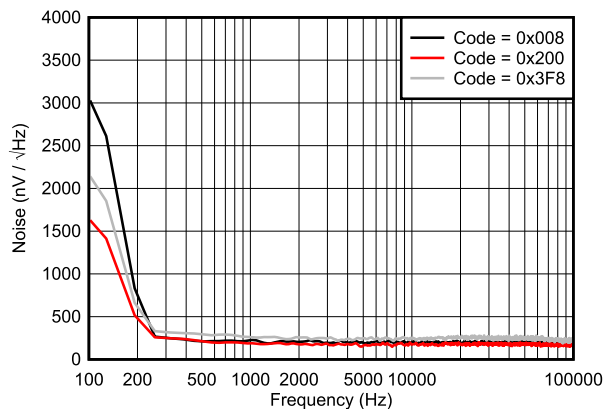
Reference =  $V_{DD} = 5.5\text{ V}$ , Fast+ mode, DAC at midscale, DAC load =  $5\text{ k}\Omega \parallel 200\text{ pF}$

图 7-41. Clock Feedthrough



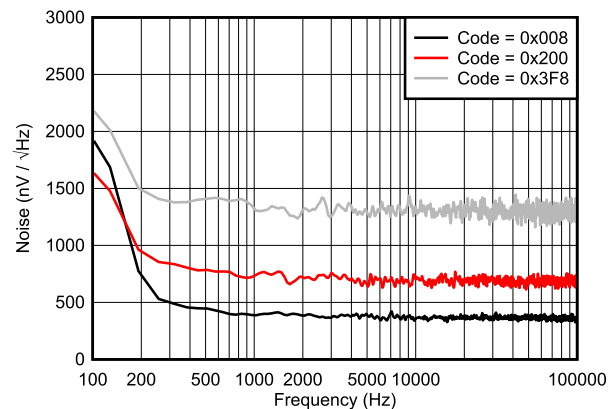
Internal reference (gain = 4x),  $V_{DD} = 5.25\text{ V} + 0.25\text{ V}_{PP}$ , DAC at midscale, DAC load =  $5\text{ k}\Omega \parallel 200\text{ pF}$

图 7-42. DAC Output AC PSRR vs Frequency



Reference =  $V_{DD} = 5.5\text{ V}$

图 7-43. DAC Output Noise Spectral Density

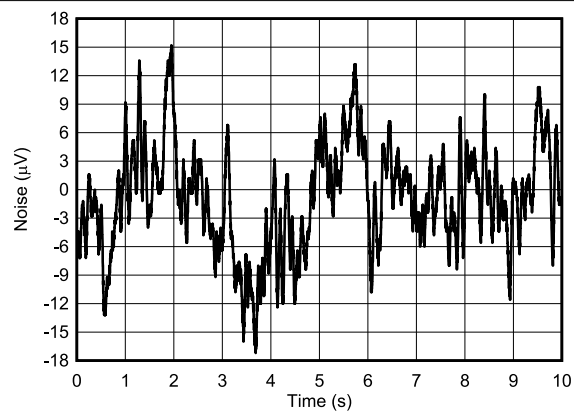


Internal reference (gain = 4x),  $V_{DD} = 5.5\text{ V}$

图 7-44. DAC Output Noise Spectral Density

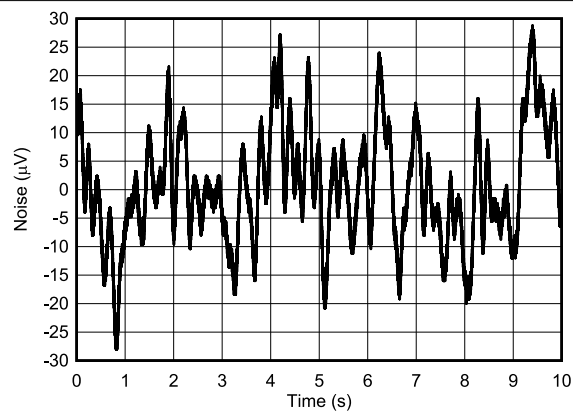
## 7.11 Typical Characteristics (continued)

at  $T_A = 25^\circ\text{C}$ , 10-bit DAC, and DAC outputs unloaded (unless otherwise noted)



Reference =  $V_{DD} = 5.5\text{ V}$ , DAC at midscale

**图 7-45. DAC Output Noise: 0.1 Hz to 10 Hz**



Internal reference (gain = 4x),  $V_{DD} = 5.5\text{ V}$ , DAC at midscale

**图 7-46. DAC Output Noise: 0.1 Hz to 10 Hz**

## 8 Detailed Description

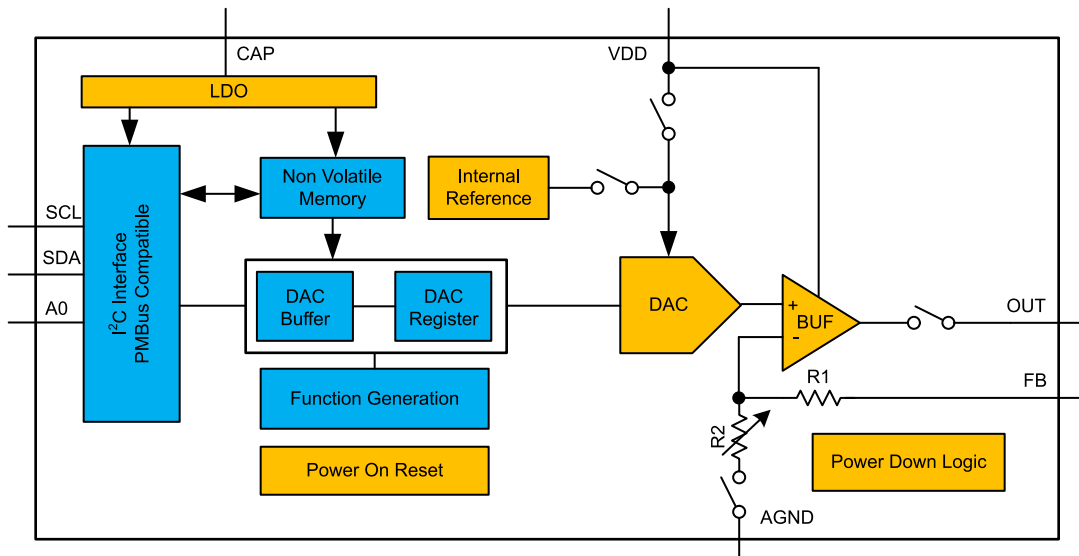
### 8.1 Overview

The 10-bit DAC53401-Q1 and 8-bit DAC43401-Q1 (DACx3401-Q1) are a pin-compatible family of automotive, buffered voltage-output, smart digital-to-analog converters (DACs). These smart DACs contain nonvolatile memory (NVM), an internal reference, a PMBus-compatible I<sup>2</sup>C interface, and a force-sense output. The DACx3401-Q1 operate with either an internal reference or with a power supply as the reference, and provide a full-scale output of 1.8 V to 5.5 V.

The devices communicate through an I<sup>2</sup>C interface and support I<sup>2</sup>C standard mode (100 kbps), fast mode (400 kbps), and fast mode plus (1 Mbps). These devices also support specific PMBus commands such as *turn on/off*, *margin high or low*, and more. The DACx3401-Q1 also include digital slew rate control, and support basic signal generation such as *square*, *ramp*, and *sawtooth* waveforms. These devices can generate pulse-width modulation (PWM) output with the combination of the triangular or sawtooth waveform and the FB pin. These features enable DACx3401-Q1 to go beyond the limitations of a conventional DAC that depends on a processor to function. Because of processor-less operation and the smart feature set, the DACx3401-Q1 are called smart DACs.

The DACx3401-Q1 devices have a power-on-reset (POR) circuit that makes sure all the registers start with default or user-programmed settings using NVM. The DAC output powers on in high-impedance mode (default); this setting can be programmed to 10k $\Omega$ -GND using NVM.

### 8.2 Functional Block Diagram



## 8.3 Feature Description

### 8.3.1 Digital-to-Analog Converter (DAC) Architecture

The DACx3401-Q1 family of devices consists of string architecture with an output buffer amplifier. [Figure 8.2](#) shows the DAC architecture within the block diagram. This DAC architecture operates from a 1.8-V to 5.5-V power supply. These devices consume only 0.2 mA of current when using a 1.8-V power supply. The DAC output pin starts up in high impedance mode making it an excellent choice for power-supply control applications. To change the power-up mode to 10kΩ-GND, program the DAC\_PD bit (address: D1h), and load these bits in the device NVM. The DACx3401-Q1 devices include a *smart* feature set to enable processor-less operation and high-integration. The NVM enables a predictable startup. The integrated functions and the FB pin enable PWM output for control applications. The FB pin enables this device to be used as a programmable comparator. The digital slew rate control and the Hi-Z power-down modes enable a hassle-free voltage margining and function.

#### 8.3.1.1 Reference Selection and DAC Transfer Function

The device writes the input data to the DAC data registers in straight-binary format. After a power-on or a reset event, the device sets all DAC registers to the values set in the NVM.

##### 8.3.1.1.1 Power Supply as Reference

By default, the DACx3401-Q1 operate with the power-supply pin (VDD) as a reference. [Equation 1](#) shows DAC transfer function when the power-supply pin is used as reference.

$$V_{OUT} = \frac{DAC\_DATA}{2^N} \times V_{DD} \quad (1)$$

where

- N is the resolution in bits, either 8 (DAC43401-Q1) or 10 (DAC53401-Q1).
- DAC\_DATA is the decimal equivalent of the binary code that is loaded to the DAC register.
- DAC\_DATA ranges from 0 to  $2^N - 1$ .
- $V_{DD}$  is used as the DAC reference voltage.

##### 8.3.1.1.2 Internal Reference

The DACx3401-Q1 also contain an internal reference that is disabled by default. Enable the internal reference by writing 1 to REF\_EN (address D1h). The internal reference generates a fixed 1.21-V voltage (typical). Using DAC\_SPAN (address D1h) bits, gain of 1.5x, 2x, 3x, 4x can be achieved for the DAC output voltage ( $V_{OUT}$ ) [Equation 2](#) shows DAC transfer function when the internal reference is used.

$$V_{OUT} = \frac{DAC\_DATA}{2^N} \times V_{REF} \times GAIN \quad (2)$$

where

- N is the resolution in bits, either 8 (DAC43401-Q1) or 10 (DAC53401-Q1).
- DAC\_DATA is the decimal equivalent of the binary code that is loaded to the DAC register
- DAC\_DATA ranges from 0 to  $2^N - 1$ .
- $V_{REF}$  is the internal reference voltage = 1.21 V.
- GAIN = 1.5x, 2x, 3x, 4x based on DAC\_SPAN (address D1h) bits.

### 8.3.2 DAC Update

The DAC output pin (OUT) is updated at the end of I<sup>2</sup>C DAC write frame.

#### 8.3.2.1 DAC Update Busy

The DAC\_UPDATE\_BUSY bit (address D0h) is set to 1 by the device when certain DAC update operations, such as *function generation*, *transition to margin high or low*, or any of the medical alarms are in progress. When the DAC\_UPDATE\_BUSY bit is set to 1, do not write to any of the DAC registers. After the DAC update operation is completed (DAC\_UPDATE\_BUSY = 0), any of the DAC registers can be written.

### 8.3.3 Nonvolatile Memory (EEPROM or NVM)

The DACx3401-Q1 contain nonvolatile memory (NVM) bits. These memory bits are user programmable and erasable, and retain the set values in the absence of a power supply. All the register bits, as shown in 表 8-1, can be stored in the device NVM by setting NVM\_PROG = 1 (address D3h). The NVM\_BUSY bit (address D0h) is set to 1 by device when a NVM write or reload operation is ongoing. During this time, the device blocks all write operations to the device. The NVM\_BUSY bit is set to 0 after the write or reload operation is complete; at this point, all write operations to the device are allowed. The default value for all the registers in the DACx3401-Q1 is loaded from NVM as soon as a POR event is issued. Do not perform a read operation from the DAC register while NVM\_BUSY = 1.

表 8-1. NVM Programmable Registers

| REGISTER ADDRESS | REGISTER NAME   | BIT ADDRESS | BIT NAME                              |
|------------------|-----------------|-------------|---------------------------------------|
| D1h              | GENERAL_CONFIG  | 15:14       | FUNC_CONFIG                           |
|                  |                 | 13          | DEVICE_LOCK                           |
|                  |                 | 11:9        | CODE_STEP                             |
|                  |                 | 8:5         | SLEW_RATE                             |
|                  |                 | 4:3         | DAC_PDN                               |
|                  |                 | 2           | REF_EN                                |
|                  |                 | 1:0         | DAC_SPAN                              |
| D3h              | TRIGGER         | 8           | START_FUNC_GEN                        |
| 10h              | DAC_DATA        | 11:2        | DAC_DATA                              |
| 25h              | DAC_MARGIN_HIGH | 11:4        | MARGIN_HIGH (8 most significant bits) |
| 26h              | DAC_MARGIN_LOW  | 11:4        | MARGIN_LOW (8 most significant bits)  |

The DACx3401-Q1 also implement NVM\_RELOAD bit (address D3h). Set this bit to 1 for the device to start an NVM reload operation. After the operation is complete, the device autoresets this bit to 0. During the NVM\_RELOAD operation, the NVM\_BUSY bit is set to 1.

#### 8.3.3.1 NVM Cyclic Redundancy Check

The DACx3401-Q1 implement a cyclic redundancy check (CRC) feature for the device NVM to make sure that the data stored in the device NVM is uncorrupted. There are two types of CRC alarm bits implemented in DACx3401-Q1:

- NVM\_CRC\_ALARM\_USER
- NVM\_CRC\_ALARM\_INTERNAL

The NVM\_CRC\_ALARM\_USER bit indicates the status of user-programmable NVM bits, and the NVM\_CRC\_ALARM\_INTERNAL bit indicates the status of internal NVM bits. The CRC feature is implemented by storing a 10-Bit CRC (CRC-10-ATM) along with the NVM data each time NVM program operation (write or reload) is performed and during the device start up. The device reads the NVM data and validates the data with the stored CRC. The CRC alarm bits (NVM\_CRC\_ALARM\_USER and NVM\_CRC\_ALARM\_INTERNAL address D0h) report any errors after the data are read from the device NVM.

### 8.3.3.2 NVM\_CRC\_ALARM\_USER Bit

A logic 1 on NVM\_CRC\_ALARM\_USER bit indicates that the user-programmable NVM data is corrupt. During this condition, all registers in the DAC are initialized with factory reset values, and any DAC registers can be written to or read from. To reset the alarm bits to 0, issue a software reset (see [§ 8.3.6](#)) command, or cycle power to the DAC. Alternatively, cycle the power to reload the user-programmable NVM bits.

### 8.3.3.3 NVM\_CRC\_ALARM\_INTERNAL Bit

A logic 1 on NVM\_CRC\_ALARM\_INTERNAL bit indicates that the internal NVM data is corrupt. During this condition, all registers in the DAC are initialized with factory reset values, and any DAC registers can be written to or read from. To reset the alarm bits to 0, issue a software reset (see [§ 8.3.6](#)) command or cycle power to the DAC.

### 8.3.4 Programmable Slew Rate

When the DAC data registers are written, the voltage on DAC output ( $V_{OUT}$ ) immediately transitions to the new code following the slew rate and settling time specified in [§ 7.5](#). The slew rate control feature allows the user to control the rate at which the output voltage ( $V_{OUT}$ ) changes. When this feature is enabled (using SLEW\_RATE[3:0] bits), the DAC output changes from the current code to the code in MARGIN\_HIGH (address 25h) or MARGIN\_LOW (address 26h) registers (when margin high or low commands are issued to the DAC) using the step and rate set in CODE\_STEP and SLEW\_RATE bits. With the default slew rate control setting (CODE\_STEP and SLEW\_RATE bits, address D1h), the output changes smoothly at a rate limited by the output drive circuitry and the attached load. Using this feature, the output steps digitally at a rate defined by bits CODE\_STEP and SLEW\_RATE on address D1h. SLEW\_RATE defines the rate at which the digital slew updates; CODE\_STEP defines the amount by which the output value changes at each update. [表 8-2](#) and [表 8-3](#) show different settings for CODE\_STEP and SLEW\_RATE.

When the slew rate control feature is used, the output changes happen at the programmed slew rate. This configuration results in a staircase formation at the output. Do not write to CODE\_STEP, SLEW\_RATE, or DAC\_DATA during the output slew.

**表 8-2. Code Step**

| REGISTER ADDRESS<br>AND NAME | CODE_STEP[2] | CODE_STEP[1] | CODE_STEP[0] | COMMENT                             |
|------------------------------|--------------|--------------|--------------|-------------------------------------|
| D1h, GENERAL_CONFIG          | 0            | 0            | 0            | Code step size = 1 LSB<br>(default) |
|                              | 0            | 0            | 1            | Code step size = 2 LSB              |
|                              | 0            | 1            | 0            | Code step size = 3 LSB              |
|                              | 0            | 1            | 1            | Code step size = 4 LSB              |
|                              | 1            | 0            | 0            | Code step size = 6 LSB              |
|                              | 1            | 0            | 1            | Code step size = 8 LSB              |
|                              | 1            | 1            | 0            | Code step size = 16 LSB             |
|                              | 1            | 1            | 1            | Code step size = 32 LSB             |

表 8-3. Slew Rate

| REGISTER<br>ADDRESS AND<br>NAME | SLEW_RATE[3] | SLEW_RATE[2] | SLEW_RATE[1] | SLEW_RATE[0] | COMMENT                                   |
|---------------------------------|--------------|--------------|--------------|--------------|-------------------------------------------|
| D1h,<br>GENERAL_CONFIG          | 0            | 0            | 0            | 0            | 25.6 $\mu$ s<br>(per step)                |
|                                 | 0            | 0            | 0            | 1            | 25.6 $\mu$ s $\times$ 1.25<br>(per step)  |
|                                 | 0            | 0            | 1            | 0            | 25.6 $\mu$ s $\times$ 1.50<br>(per step)  |
|                                 | 0            | 0            | 1            | 1            | 25.6 $\mu$ s $\times$ 1.75<br>(per step)  |
|                                 | 0            | 1            | 0            | 0            | 204.8 $\mu$ s<br>(per step)               |
|                                 | 0            | 1            | 0            | 1            | 204.8 $\mu$ s $\times$ 1.25<br>(per step) |
|                                 | 0            | 1            | 1            | 0            | 204.8 $\mu$ s $\times$ 1.50<br>(per step) |
|                                 | 0            | 1            | 1            | 1            | 204.8 $\mu$ s $\times$ 1.75<br>(per step) |
|                                 | 1            | 0            | 0            | 0            | 1.6384 ms (per step)                      |
|                                 | 1            | 0            | 0            | 1            | 1.6384 ms $\times$ 1.25<br>(per step)     |
|                                 | 1            | 0            | 1            | 0            | 1.6384 ms $\times$ 1.50<br>(per step)     |
|                                 | 1            | 0            | 1            | 1            | 1.6384 ms $\times$ 1.75<br>(per step)     |
|                                 | 1            | 1            | 0            | 0            | 12 $\mu$ s (per step)                     |
|                                 | 1            | 1            | 0            | 1            | 8 $\mu$ s (per step)                      |
|                                 | 1            | 1            | 1            | 0            | 4 $\mu$ s (per step)                      |
|                                 | 1            | 1            | 1            | 1            | No slew (default)                         |

### 8.3.5 Power-on-Reset (POR)

The DACx3401-Q1 family of devices includes a power-on reset (POR) function that controls the output voltage at power up. After the  $V_{DD}$  supply has been established, a POR event is issued. The POR causes all registers to initialize to default values, and communication with the device is valid only after a 30-ms, POR delay. The default value for all the registers in the DACx3401-Q1 is loaded from NVM as soon as the POR event is issued.

When the device powers up, a POR circuit sets the device to the default mode. The POR circuit requires specific  $V_{DD}$  levels, as indicated in 图 8-1, in order to make sure that the internal capacitors discharge and reset the device on power up. To make sure that a POR occurs,  $V_{DD}$  must be less than 0.7 V for at least 1 ms. When  $V_{DD}$  drops to less than 1.65 V, but remains greater than 0.7 V (shown as the undefined region), the device may or may not reset under all specified temperature and power-supply conditions. In this case, initiate a POR. When  $V_{DD}$  remains greater than 1.65 V, a POR does not occur.

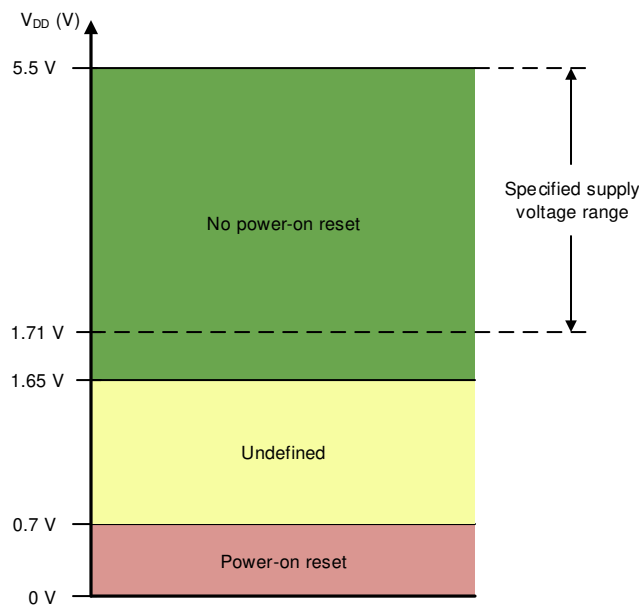


图 8-1. Threshold Levels for  $V_{DD}$  POR Circuit

### 8.3.6 Software Reset

To initiate a device software reset event, write the reserved code 1010 to the SW\_RESET (address D3h). A software reset initiates a POR event.

### 8.3.7 Device Lock Feature

The DACx3401-Q1 implement a device lock feature that prevents an accidental or unintended write to the DAC registers. The device locks all the registers when the DEVICE\_LOCK bit (address D1h) is set to 1. To bypass the DEVICE\_LOCK setting, write 0101 to the DEVICE\_UNLOCK\_CODE bits (address D3h).

### 8.3.8 PMBus Compatibility

The PMBus protocol is an I<sup>2</sup>C-based communication standard for power-supply management. PMBus contains standard command codes tailored to power supply applications. The DACx3401-Q1 implement some PMBus commands such as *Turn Off*, *Turn On*, *Margin Low*, *Margin High*, *Communication Failure Alert Bit (CML)*, as well as *PMBUS revision*. 图 8-2 shows typical PMBus connections. The EN\_PMBus bit (Bit 12, address D1h) must be set to 1 to enable the PMBus protocol.

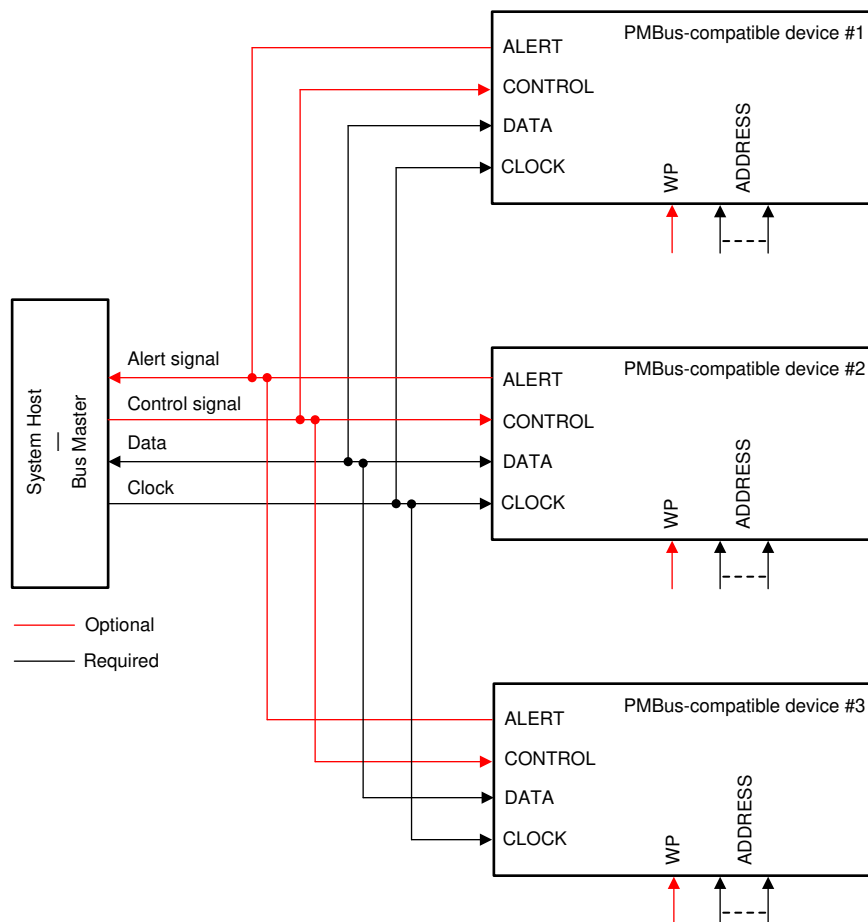


图 8-2. PMBus Connections

Similar to I<sup>2</sup>C, PMBus is a variable length packet of 8-bit data bytes, each with a receiver acknowledge, wrapped between a start and stop bit. The first byte is always a 7-bit *slave address* followed by a *write* bit, sometimes called the *even address* that identifies the intended receiver of the packet. The second byte is an 8-bit *command* byte, identifying the PMBus command being transmitted using the respective command code. After the command byte, the transmitter either sends data associated with the command to write to the receiver command register (from most significant byte to least significant byte), or sends a new start bit indicating the desire to read the data associated with the command register from the receiver. After, the receiver transmits the data following the same most significant byte first format (see 表 8-7).

## 8.4 Device Functional Modes

### 8.4.1 Power Down Mode

The DACx3401-Q1 output amplifier and internal reference can be independently powered down through the DAC\_PDN bits (address D1h). At power up, the DAC output and the internal reference are disabled by default. In power-down mode, the DAC output (OUT pin) is in a high-impedance state. To change this state to 10kΩ- $A_{GND}$  (at power up), use the DAC\_PDN bits (address D1h).

The DAC power-up state can be programmed to any state (power-down or normal mode) using the NVM. 表 8-4 shows the DAC power-down bits.

**表 8-4. DAC Power-Down Bits**

| REGISTER ADDRESS AND NAME | DAC_PDN[1] | DAC_PDN[0] | DESCRIPTION                                   |
|---------------------------|------------|------------|-----------------------------------------------|
| D1h, GENERAL_CONFIG       | 0          | 0          | Power up                                      |
|                           | 0          | 1          | Power down to 10 kΩ                           |
|                           | 1          | 0          | Power down to high impedance (Hi-Z) (default) |
|                           | 1          | 1          | Power down to 10 kΩ                           |

### 8.4.2 Continuous Waveform Generation (CWG) Mode

The DACx3401-Q1 implement a continuous waveform generation feature. To set the device to this mode, set the START\_FUNC\_GEN (address D3h) to 1. In this mode, the DAC output pin (OUT) generates a continuous waveform based on the FUNC\_CONFIG bits (address D1h). 表 8-5 shows the continuous waveforms that can be generated in this mode. The frequency of the waveform depends on the resistive and capacitive load on the OUT pin, high and low codes, and slew rate settings as shown in the following equations.

$$f_{\text{SQUARE-WAVE}} = \frac{1}{2 \times \text{SLEW\_RATE}} \quad (3)$$

$$f_{\text{TRIANGLE-WAVE}} = \frac{1}{2 \times \text{SLEW\_RATE} \times \left( \frac{\text{MARGIN\_HIGH} - \text{MARGIN\_LOW} + 1}{\text{CODE\_STEP}} \right)} \quad (4)$$

$$f_{\text{SAWTOOTH-WAVE}} = \frac{1}{\text{SLEW\_RATE} \times \left( \frac{\text{MARGIN\_HIGH} - \text{MARGIN\_LOW} + 1}{\text{CODE\_STEP}} \right)} \quad (5)$$

where:

- SLEW\_RATE is the programmable DAC slew rate specified in 表 8-3.
- MARGIN\_HIGH and MARGIN\_LOW are the programmable DAC codes.
- CODE\_STEP is the programmable DAC step code in 表 8-2.

表 8-5. FUNC\_CONFIG bits

| REGISTER ADDRESS AND NAME | FUNC_CONFIG[1] | FUNC_CONFIG[0] | DESCRIPTION                                                                                                                                                                            |
|---------------------------|----------------|----------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| D1h, GENERAL_CONFIG       | 0              | 0              | Generates a triangle wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code with slope defined by SLEW_RATE (address D1h) bits                                   |
|                           | 0              | 1              | Generates Saw-Tooth wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code, with rising slope defined by SLEW_RATE (address D1h) bits and immediate falling edge |
|                           | 1              | 0              | Generates Saw-Tooth wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code, with falling slope defined by SLEW_RATE (address D1h) bits and immediate rising edge |
|                           | 1              | 1              | Generates a square wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code with pulse high and low period defined by SLEW_RATE (address D1h) bits                 |

### 8.4.3 PMBus Compatibility Mode

The DACx3401-Q1 I<sup>2</sup>C interface implements some of the PMBus commands. 表 8-6 shows the supported PMBus commands that are implemented in DACx3401-Q1. The DAC uses MARGIN\_LOW (address 26h), MARGIN\_HIGH (address 25h) bits, SLEW\_RATE, and CODE\_STEP bits (address D1h) for PMBUS\_OPERATION\_CMD. The EN\_PMBus bit (Bit 12, address D1h) must be set to 1 to enable the PMBus protocol.

表 8-6. PMBus Operation Commands

| REGISTER ADDRESS AND NAME | PMBUS_OPERATION_CMD[15:8] | DESCRIPTION |
|---------------------------|---------------------------|-------------|
| 01h, PMBUS_OPERATION      | 00h                       | Turn off    |
|                           | 80h                       | Turn on     |
|                           | 94h                       | Margin low  |
|                           | A4h                       | Margin high |

The DACx3401-Q1 also implement PMBus features such as group command protocol and communication time-out failure. The CML bit (address 78h) indicates a communication fault in the PMBus. This bit is reset by writing 1. In case of timeout, if the SDA line is held low, the SDA line stays low during the time-out event until next SCL pulse is received.

To get the PMBus version, read the PMBUS\_VERSION bits (address 98h).

## 8.5 Programming

The DACx3401-Q1 devices have a 2-wire serial interface (SCL and SDA), and one address pin (A0), as shown in the pin diagram of 节 6. The I<sup>2</sup>C bus consists of a data line (SDA) and a clock line (SCL) with pullup structures. When the bus is idle, both SDA and SCL lines are pulled high. All the I<sup>2</sup>C-compatible devices connect to the I<sup>2</sup>C bus through the open drain I/O pins, SDA and SCL.

The I<sup>2</sup>C specification states that the device that controls communication is called a *master*, and the devices that are controlled by the master are called *slaves*. The master device generates the SCL signal. The master device also generates special timing conditions (start condition, repeated start condition, and stop condition) on the bus to indicate the start or stop of a data transfer. Device addressing is completed by the master. The master device on an I<sup>2</sup>C bus is typically a microcontroller or digital signal processor (DSP). The DACx3401-Q1 family operates as a slave device on the I<sup>2</sup>C bus. A slave device acknowledges master commands, and upon master control, receives or transmits data.

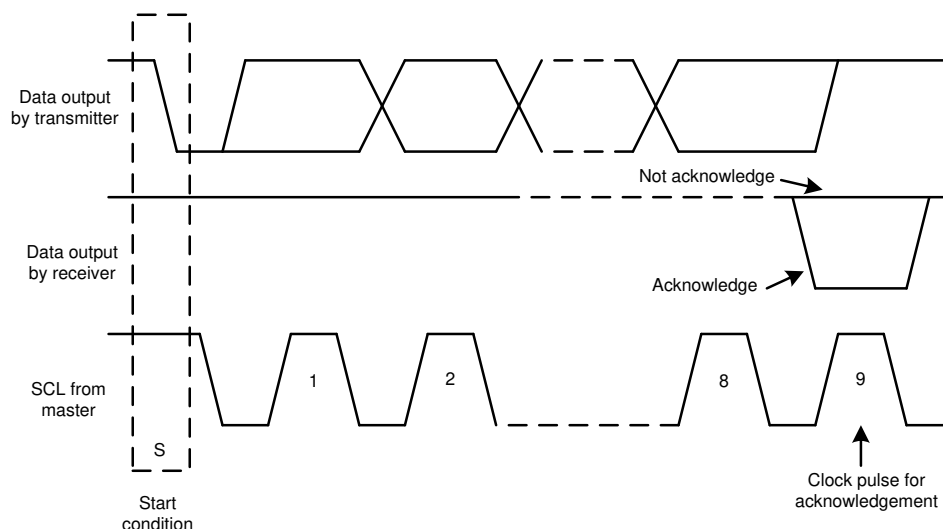
Typically, the DACx3401-Q1 family operates as a slave receiver. A master device writes to the DACx3401-Q1, a slave receiver. However, if a master device requires the DACx3401-Q1 internal register data, the DACx3401-Q1 operate as a slave transmitter. In this case, the master device reads from the DACx3401-Q1. According to I<sup>2</sup>C terminology, read and write refer to the master device.

The DACx3401-Q1 family is a slave and supports the following data transfer modes:

- Standard mode (100 kbps)
- Fast mode (400 kbps)
- Fast mode plus (1.0 Mbps)

The data transfer protocol for standard and fast modes is exactly the same; therefore, both modes are referred to as *F/S-mode* in this document. The fast mode plus protocol is supported in terms of data transfer speed, but not output current. The low-level output current would be 3 mA; similar to the case of standard and fast modes. The DACx3401-Q1 family supports 7-bit addressing. The 10-bit addressing mode is not supported. The device supports the general call reset function. Sending the following sequence initiates a software reset within the device: start or repeated start, 0x00, 0x06, stop. The reset is asserted within the device on the rising edge of the ACK bit, following the second byte.

Other than specific timing signals, the I<sup>2</sup>C interface works with serial bytes. At the end of each byte, a ninth clock cycle generates and detects an acknowledge signal. An acknowledge is when the SDA line is pulled low during the high period of the ninth clock cycle. A not-acknowledge is when the SDA line is left high during the high period of the ninth clock cycle, as shown in 图 8-3.



**图 8-3. Acknowledge and Not Acknowledge on the I<sup>2</sup>C Bus**

### 8.5.1 F/S Mode Protocol

The following steps explain a complete transaction in F/S mode.

1. The master initiates data transfer by generating a start condition. The start condition is when a high-to-low transition occurs on the SDA line while SCL is high, as shown in 图 8-4. All I<sup>2</sup>C-compatible devices recognize a start condition.
2. The master then generates the SCL pulses, and transmits the 7-bit address and the read/write direction bit ( $R/\overline{W}$ ) on the SDA line. During all transmissions, the master makes sure that data are valid. A valid data condition requires the SDA line to be stable during the entire high period of the clock pulse, as shown in 图 8-5. All devices recognize the address sent by the master and compare the address to the respective internal fixed address. Only the slave device with a matching address generates an acknowledge by pulling the SDA line low during the entire high period of the 9th SCL cycle, as shown in Figure 8-3. When the master detects this acknowledge, the communication link with a slave has been established.
3. The master generates further SCL cycles to transmit ( $R/\overline{W}$  bit 0) or receive ( $R/\overline{W}$  bit 1) data to the slave. In either case, the receiver must acknowledge the data sent by the transmitter. The acknowledge signal can be generated by the master or by the slave, depending on which is the receiver. The 9-bit valid data sequences consists of 8-data bits and 1 acknowledge-bit, and can continue as long as necessary.
4. To signal the end of the data transfer, the master generates a stop condition by pulling the SDA line from low-to-high while the SCL line is high, as shown in 图 8-4. This action releases the bus and stops the communication link with the addressed slave. All I<sup>2</sup>C-compatible devices recognize the stop condition. Upon receipt of a stop condition, the bus is released, and all slave devices then wait for a start condition followed by a matching address.

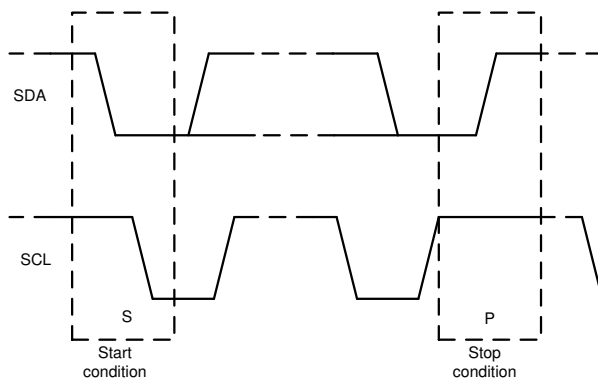


图 8-4. Start and Stop Conditions

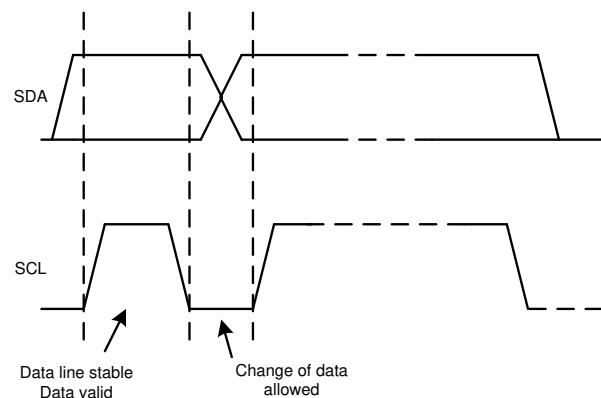


图 8-5. Bit Transfer on the I<sup>2</sup>C Bus

### 8.5.2 I<sup>2</sup>C Update Sequence

For a single update, the DACx3401-Q1 require a start condition, a valid I<sup>2</sup>C address byte, a command byte, and two data bytes, as listed in 表 8-7.

表 8-7. Update Sequence

| MSB                           | .... | LSB | ACK | MSB                       | ... | LSB | ACK | MSB              | ... | LSB | ACK | MSB              | ... | LSB | ACK |
|-------------------------------|------|-----|-----|---------------------------|-----|-----|-----|------------------|-----|-----|-----|------------------|-----|-----|-----|
| Address (A) byte<br>节 8.5.2.1 |      |     |     | Command byte<br>节 8.5.2.2 |     |     |     | Data byte - MSDB |     |     |     | Data byte - LSDB |     |     |     |
| DB [31:24]                    |      |     |     | DB [23:16]                |     |     |     | DB [15:8]        |     |     |     | DB [7:0]         |     |     |     |

After each byte is received, the DACx3401-Q1 family acknowledges the byte by pulling the SDA line low during the high period of a single clock pulse, as shown in 图 8-6. These four bytes and acknowledge cycles make up the 36 clock cycles required for a single update to occur. A valid I<sup>2</sup>C address byte selects the DACx3401-Q1 devices.

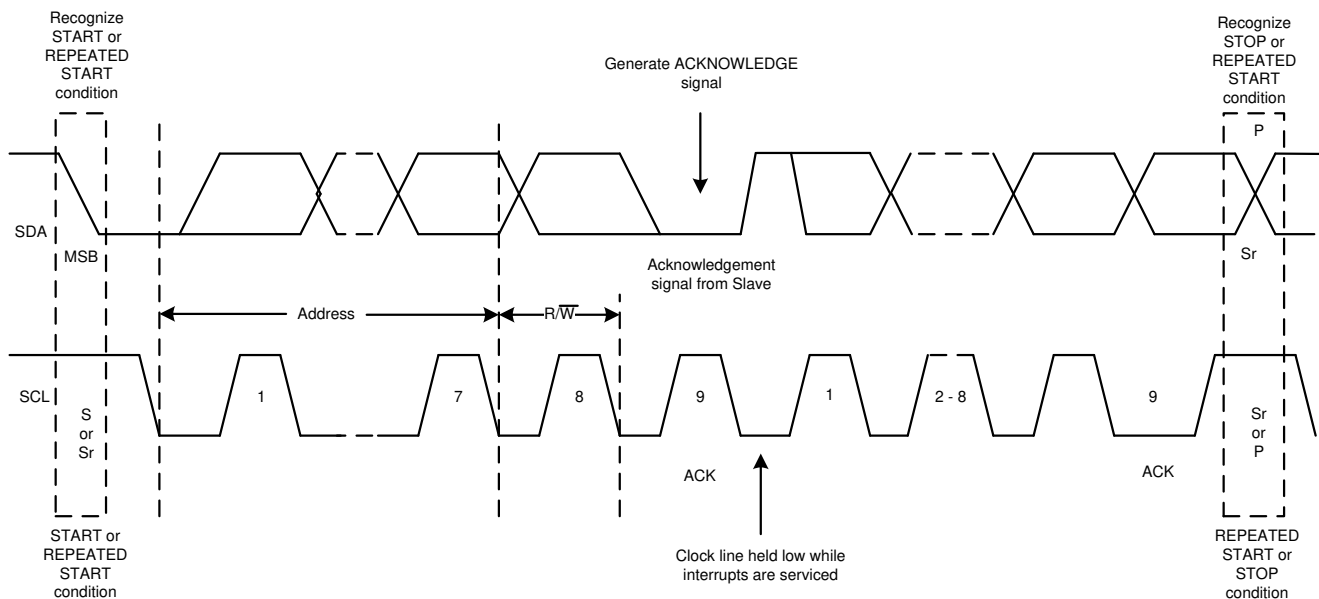


图 8-6. I<sup>2</sup>C Bus Protocol

The command byte sets the operating mode of the selected DACx3401-Q1 device. For a data update to occur when the operating mode is selected by this byte, the DACx3401-Q1 device must receive two data bytes: the most significant data byte (MSDB) and least significant data byte (LSDB). The DACx3401-Q1 device performs an update on the falling edge of the acknowledge signal that follows the LSDB.

When using fast mode (clock = 400 kHz), the maximum DAC update rate is limited to 10 kSPS. Using the fast mode plus (clock = 1 MHz), the maximum DAC update rate is limited to 25 kSPS. When a stop condition is received, the DACx3401-Q1 device releases the I<sup>2</sup>C bus and awaits a new start condition.

### 8.5.2.1 Address Byte

The address byte, as shown in 表 8-8, is the first byte received from the master device following the start condition. The first four bits (MSBs) of the address are factory preset to 1001. The next three bits of the address are controlled by the A0 pin. The A0 pin input can be connected to VDD, AGND, SCL, or SDA. The A0 pin is sampled during the first byte of each data frame to determine the address. The device latches the value of the address pin, and consequently responds to that particular address according to 表 8-9.

**表 8-8. Address Byte**

| COMMENT           | MSB |     |     |     |                                     |     |     | LSB               |
|-------------------|-----|-----|-----|-----|-------------------------------------|-----|-----|-------------------|
| —                 | AD6 | AD5 | AD4 | AD3 | AD2                                 | AD1 | AD0 | R/ $\overline{W}$ |
| General address   | 1   | 0   | 0   | 1   | See 表 8-9<br>(slave address column) |     |     | 0 or 1            |
| Broadcast address | 1   | 0   | 0   | 0   | 1                                   | 1   | 1   | 0                 |

The DACx3401-Q1 supports broadcast addressing, which is used for synchronously updating or powering down multiple DACx3401-Q1 devices. When the broadcast address is used, the DACx3401-Q1 responds regardless of the address pin state. Broadcast is supported only in write mode.

**表 8-9. Address Format**

| SLAVE ADDRESS | A0 PIN |
|---------------|--------|
| 000           | AGND   |
| 001           | VDD    |
| 010           | SDA    |
| 011           | SCL    |

### 8.5.2.2 Command Byte

表 8-10 lists the command byte.

**表 8-10. Command Byte (Register Names)**

| ADDRESS | REGISTER NAME     |
|---------|-------------------|
| D0h     | STATUS            |
| D1h     | GENERAL_CONFIG    |
| D3h     | TRIGGER           |
| 21h     | DAC_DATA          |
| 25h     | DAC_MARGIN_HIGH   |
| 26h     | DAC_MARGIN_LOW    |
| 01h     | PMBUS_OP          |
| 78h     | PMBUS_STATUS_BYTE |
| 98h     | PMBUS_VERSION     |

### 8.5.3 I<sup>2</sup>C Read Sequence

To read any register the following command sequence must be used:

1. Send a start or repeated start command with a slave address and the R/  $\overline{W}$  bit set to 0 for writing. The device acknowledges this event.
2. Send a command byte for the register to be read. The device acknowledges this event again.
3. Send a repeated start with the slave address and the R/  $\overline{W}$  bit set to 1 for reading. The device acknowledges this event.
4. The device writes the MSDB byte of the addressed register. The master must acknowledge this byte.
5. Finally, the device writes out the LSDB of the register.

An alternative reading method allows for reading back the value of the last register written. The sequence is a start or repeated start with the slave address and the R/  $\overline{W}$  bit set to 1, and the two bytes of the last register are read out.

The broadcast address cannot be used for reading.

**表 8-11. Read Sequence**

| S           | MSB                          | ... | R/ W<br>(0) | ACK   | MSB                          | ... | LSB | ACK | Sr    | MSB                          | ... | R/ W<br>(1) | ACK | MSB   | ...        | LSB | ACK | MSB    | ...        | LSB | ACK |        |
|-------------|------------------------------|-----|-------------|-------|------------------------------|-----|-----|-----|-------|------------------------------|-----|-------------|-----|-------|------------|-----|-----|--------|------------|-----|-----|--------|
|             | ADDRESS<br>BYTE<br>节 8.5.2.1 |     |             |       | COMMAND<br>BYTE<br>节 8.5.2.2 |     |     |     | Sr    | ADDRESS<br>BYTE<br>节 8.5.2.1 |     |             |     | MSDB  |            |     |     | LSDB   |            |     |     |        |
| From Master |                              |     |             | Slave | From Master                  |     |     |     | Slave | From Master                  |     |             |     | Slave | From Slave |     |     | Master | From Slave |     |     | Master |

## 8.6 Register Map

表 8-12. Register Map

| ADDR | MOST SIGNIFICANT DATA BYTE (MSDB) |                        |             |                 |                                                       |       |                     |                | LEAST SIGNIFICANT DATA BYTE (LSDB) |                  |            |          |          |        |          |      |            |  |
|------|-----------------------------------|------------------------|-------------|-----------------|-------------------------------------------------------|-------|---------------------|----------------|------------------------------------|------------------|------------|----------|----------|--------|----------|------|------------|--|
|      | BIT15                             | BIT14                  | BIT13       | BIT12           | BIT11                                                 | BIT10 | BIT9                | BIT8           | BIT7                               | BIT6             | BIT5       | BIT4     | BIT3     | BIT2   | BIT1     | BIT0 |            |  |
| D0h  | NVM_CRC_ALARM_USER                | NVM_CRC_ALARM_INTERNAL | NVM_BUSY    | DAC_UPDATE_BUSY | X <sup>(1)</sup>                                      |       |                     |                |                                    |                  | DEVICE_ID  |          |          |        |          |      | VERSION_ID |  |
| D1h  | FUNC_CONFIG                       |                        | DEVICE_LOCK | EN_PMBUS        | CODE_STEP                                             |       |                     | SLEW_RATE      |                                    |                  |            | DAC_PDN  |          | REF_EN | DAC_SPAN |      |            |  |
| D3h  | DEVICE_UNLOCK_CODE                |                        |             |                 | X                                                     |       | DEVICE_CONFIG_RESET | START_FUNC_GEN | PMBUS_MARGIN_HIGH                  | PMBUS_MARGIN_LOW | NVM_RELOAD | NVM_PROG | SW_RESET |        |          |      |            |  |
| 21h  | X                                 |                        |             |                 | DAC_DATA[9:0] (10-Bit) or DAC_DATA[7:0] (8-Bit)       |       |                     |                |                                    |                  |            |          |          |        | X        |      |            |  |
| 25h  | X                                 |                        |             |                 | MARGIN_HIGH[9:0] (10-Bit) or MARGIN_HIGH[7:0] (8-Bit) |       |                     |                |                                    |                  |            |          |          |        | X        |      |            |  |
| 26h  | X                                 |                        |             |                 | MARGIN_LOW[9:0] (10-Bit) or MARGIN_LOW[7:0] (8-Bit)   |       |                     |                |                                    |                  |            |          |          |        | X        |      |            |  |
| 01h  | PMBUS_OPERATION_CMD               |                        |             |                 |                                                       |       |                     |                | N/A                                |                  |            |          |          |        |          |      |            |  |
| 78h  | X                                 |                        |             |                 |                                                       |       | CML                 |                | N/A                                |                  |            |          |          |        |          |      |            |  |
| 98h  | PMBUS_VERSION                     |                        |             |                 |                                                       |       |                     |                | N/A                                |                  |            |          |          |        |          |      |            |  |

(1) X = Don't care.

表 8-13. Register Names

| ADDRESS | REGISTER NAME     | SECTION                 |
|---------|-------------------|-------------------------|
| D0h     | STATUS            | <a href="#">节 8.6.1</a> |
| D1h     | GENERAL_CONFIG    | <a href="#">节 8.6.2</a> |
| D3h     | TRIGGER           | <a href="#">节 8.6.3</a> |
| 21h     | DAC_DATA          | <a href="#">节 8.6.4</a> |
| 25h     | DAC_MARGIN_HIGH   | <a href="#">节 8.6.5</a> |
| 26h     | DAC_MARGIN_LOW    | <a href="#">节 8.6.6</a> |
| 01h     | PMBUS_OPERATION   | <a href="#">节 8.6.7</a> |
| 78h     | PMBUS_STATUS_BYTE | <a href="#">节 8.6.8</a> |
| 98h     | PMBUS_VERSION     | <a href="#">节 8.6.9</a> |

表 8-14. Access Type Codes

| Access Type            | Code | Description                            |
|------------------------|------|----------------------------------------|
| X                      | X    | Don't care                             |
| Read Type              |      |                                        |
| R                      | R    | Read                                   |
| Write Type             |      |                                        |
| W                      | W    | Write                                  |
| Reset or Default Value |      |                                        |
| -n                     |      | Value after reset or the default value |

### 8.6.1 STATUS Register (address = D0h) [reset = 000Ch or 0014h]

图 8-7. STATUS Register

| 15                 | 14                     | 13       | 12              | 11    | 10 | 9 | 8 | 7                             | 6 | 5 | 4 | 3          | 2 | 1 | 0 |
|--------------------|------------------------|----------|-----------------|-------|----|---|---|-------------------------------|---|---|---|------------|---|---|---|
| NVM_CRC_ALARM_USER | NVM_CRC_ALARM_INTERNAL | NVM_BUSY | DAC_UPDATE_BUSY | X     |    |   |   | DEVICE_ID                     |   |   |   | VERSION_ID |   |   |   |
| R-0h               | R-0h                   | R-0h     | R-0h            | X-00h |    |   |   | 10-bit: R-0Ch<br>8-bit: R-14h |   |   |   |            |   |   |   |

表 8-15. STATUS Register Field Descriptions

| Bit    | Field                  | Type | Reset                                | Description                                                                                                                              |
|--------|------------------------|------|--------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------|
| 15     | NVM_CRC_ALARM_USER     | R    | 0                                    | 0 : No CRC error in user NVM bits<br>1: CRC error in user NVM bits                                                                       |
| 14     | NVM_CRC_ALARM_INTERNAL | R    | 0                                    | 0 : No CRC error in internal NVM<br>1: CRC error in internal NVM bits                                                                    |
| 13     | NVM_BUSY               | R    | 0                                    | 0 : NVM write or load completed, write to DAC registers allowed<br>1 : NVM write or load in progress, write to DAC registers not allowed |
| 12     | DAC_UPDATE_BUSY        | R    | 0                                    | 0 : DAC outputs updated, write to DAC registers allowed<br>1 : DAC outputs update in progress, write to DAC registers not allowed        |
| 11 - 6 | X                      | X    | 00h                                  | Don't care                                                                                                                               |
| 5 - 2  | DEVICE_ID              | R    | DAC53401-Q1: 0Ch<br>DAC43401-Q1: 14h | DAC53401-Q1: 0Ch<br>DAC43401-Q1: 14h                                                                                                     |
| 1 - 0  | VERSION_ID             |      |                                      |                                                                                                                                          |

### 8.6.2 GENERAL\_CONFIG Register (address = D1h) [reset = 01F0h]

图 8-8. GENERAL\_CONFIG Register

| 15          | 14          | 13       | 12        | 11 | 10 | 9         | 8 | 7 | 6 | 5       | 4 | 3       | 2        | 1 | 0 |
|-------------|-------------|----------|-----------|----|----|-----------|---|---|---|---------|---|---------|----------|---|---|
| FUNC_CONFIG | DEVICE_LOCK | EN_PMBUS | CODE_STEP |    |    | SLEW_RATE |   |   |   | DAC_PDN |   | REF_EN  | DAC_SPAN |   |   |
| R/ W-0h     | W-0h        | R/ W-0h  | R/ W-0h   |    |    | R/ W-Fh   |   |   |   | R/ W-2h |   | R/ W-0h | R/ W-0h  |   |   |

表 8-16. GENERAL\_CONFIG Register Field Descriptions

| Bit     | Field       | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                             |
|---------|-------------|------|-------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15 - 14 | FUNC_CONFIG | R/ W | 00    | 00 : Generates a triangle wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code with slope defined by SLEW_RATE (address D1h) bits.<br>01: Generates Saw-Tooth wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code, with rising slope defined by SLEW_RATE (address D1h) bits and immediate falling edge.<br>10: Generates Saw-Tooth wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code, with falling slope defined by SLEW_RATE (address D1h) bits and immediate rising edge.<br>11: Generates a square wave between MARGIN_HIGH (address 25h) code to MARGIN_LOW (address 26h) code with pulse high and low period defined by SLEW_RATE (address D1h) bits. |
| 13      | DEVICE_LOCK | W    | 0     | 0 : Device not locked<br>1: Device locked, the device locks all the registers. This bit can be reset (unlock device) by writing 0101 to the DEVICE_UNLOCK_CODE bits (address D3h)                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                       |
| 12      | EN_PMBUS    | R/ W | 0     | 0: PMBus mode disabled<br>1: PMBus mode enabled                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                         |

表 8-16. GENERAL\_CONFIG Register Field Descriptions (continued)

| Bit    | Field     | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                           |
|--------|-----------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 11 - 9 | CODE_STEP | R/ W | 000   | Code step for programmable slew rate control.<br>000: Code step size = 1 LSB (default)<br>001: Code step size = 2 LSB<br>010: Code step size = 3 LSB<br>011: Code step size = 4 LSB<br>100: Code step size = 6 LSB<br>101: Code step size = 8 LSB<br>110: Code step size = 16 LSB<br>111: Code step size = 32 LSB                                                                                                                                                                                                                                                                                                                                                                                     |
| 8 - 5  | SLEW_RATE | R/ W | 1111  | Slew rate for programmable slew rate control.<br>0000: 25.6 $\mu$ s (per step)<br>0001: 25.6 $\mu$ s $\times$ 1.25 (per step)<br>0010: 25.6 $\mu$ s $\times$ 1.50 (per step)<br>0011: 25.6 $\mu$ s $\times$ 1.75 (per step)<br>0100: 204.8 $\mu$ s (per step)<br>0101: 204.8 $\mu$ s $\times$ 1.25 (per step)<br>0110: 204.8 $\mu$ s $\times$ 1.50 (per step)<br>0111: 204.8 $\mu$ s $\times$ 1.75 (per step)<br>1000: 1.6384 ms (per step)<br>1001: 1.6384 ms $\times$ 1.25 (per step)<br>1010: 1.6384 ms $\times$ 1.50 (per step)<br>1011: 1.6384 ms $\times$ 1.75 (per step)<br>1100: 12 $\mu$ s (per step)<br>1101: 8 $\mu$ s (per step)<br>1110: 4 $\mu$ s (per step)<br>1111: No slew (default) |
| 4 - 3  | DAC_PDN   | R/ W | 10    | 00: Power up<br>01: Power down to 10K<br>10: Power down to high impedance (default)<br>11: Power down to 10K                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| 2      | REF_EN    | R/ W | 0     | 0: Internal reference disabled, $V_{DD}$ is DAC reference voltage, DAC output range from 0 to $V_{DD}$ .<br>1: Internal reference enabled, DAC reference = 1.21 V                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| 1 - 0  | DAC_SPAN  | R/ W | 00    | Only applicable when internal reference is enabled.<br>00: Reference to $V_{OUT}$ gain 1.5X<br>01: Reference to $V_{OUT}$ gain 2X<br>10: Reference to $V_{OUT}$ gain 3X<br>11: Reference to $V_{OUT}$ gain 4X                                                                                                                                                                                                                                                                                                                                                                                                                                                                                         |

### 8.6.3 TRIGGER Register (address = D3h) [reset = 0008h]

图 8-9. TRIGGER Register

| 15                 | 14 | 13 | 12 | 11 | 10 | 9                   | 8              | 7                 | 6                | 5          | 4        | 3        | 2 | 1 | 0 |
|--------------------|----|----|----|----|----|---------------------|----------------|-------------------|------------------|------------|----------|----------|---|---|---|
| DEVICE_UNLOCK_CODE |    |    |    | X  |    | DEVICE_CONFIG_RESET | START_FUNC_GEN | PMBUS_MARGIN_HIGH | PMBUS_MARGIN_LOW | NVM_RELOAD | NVM_PROG | SW_RESET |   |   |   |
| W-0h               |    |    |    | X  |    | W-0h                | W-0h           | R/ W-0h           | R/ W-0h          | W-0h       | W-0h     | W-8h     |   |   |   |

表 8-17. TRIGGER Register Field Descriptions

| Bit     | Field               | Type | Reset | Description                                                                                                                                                                                                                        |
|---------|---------------------|------|-------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15 - 12 | DEVICE_UNLOCK_CODE  | W    | 0000  | Write 0101 to unlock the device to bypass DEVICE_LOCK bit.                                                                                                                                                                         |
| 11 - 10 | X                   | X    | 0h    | Don't care                                                                                                                                                                                                                         |
| 9       | DEVICE_CONFIG_RESET | W    | 0     | 0: Device configuration reset not initiated<br>1: Device configuration reset initiated. All registers loaded with factory reset values.                                                                                            |
| 8       | START_FUNC_GEN      | W    | 0     | 0: Continuous waveform generation mode disabled<br>1: Continuous waveform generation mode enabled, device generates continuous waveform based on FUNC_CONFIG (D1h), MARGIN_LOW (address 18h), and SLEW_RATE (address D1h) bits.    |
| 7       | PMBUS_MARGIN_HIGH   | R/ W | 0     | 0: PMBus margin high command not initiated<br>1: PMBus margin high command initiated, DAC output margins high to MARGIN_HIGH code (address 25h). This bit automatically resets to 0 after the DAC code reaches MARGIN_HIGH value.  |
| 6       | PMBUS_MARGIN_LOW    | R/ W | 0     | 0: PMBus margin low command not initiated<br>1: PMBus margin low command initiated, DAC output margins low to MARGIN_LOW code (address 26h). This bit automatically resets to 0 after the DAC code reaches MARGIN_LOW value.       |
| 5       | NVM_RELOAD          | W    | 0     | 0: NVM reload not initiated<br>1: NVM reload initiated, applicable DAC registers loaded with corresponding NVM. NVM_BUSY bit set to 1 while this operation is in progress. This bit is self-resetting.                             |
| 4       | NVM_PROG            | W    | 0     | 0: NVM write not initiated<br>1: NVM write initiated, NVM corresponding to applicable DAC registers loaded with existing register settings. NVM_BUSY bit set to 1 while this operation is in progress. This bit is self-resetting. |
| 3 - 0   | SW_RESET            | W    | 1000  | 1000: Software reset not initiated<br>1010: Software reset initiated, DAC registers loaded with corresponding NVMs, all other registers loaded with default settings.                                                              |

### 8.6.4 DAC\_DATA Register (address = 21h) [reset = 0000h]

图 8-10. DAC\_DATA Register

| 15   | 14 | 13 | 12 | 11                                               | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1    | 0 |
|------|----|----|----|--------------------------------------------------|----|---|---|---|---|---|---|---|---|------|---|
| X    |    |    |    | DAC_DATA[9:0] / DAC_DATA[7:0] – MSB Left aligned |    |   |   |   |   |   |   |   |   | X    |   |
| X-0h |    |    |    | W-000h                                           |    |   |   |   |   |   |   |   |   | X-0h |   |

表 8-18. DAC\_DATA Register Field Descriptions

| Bit   | Field                         | Type | Reset | Description                                                                                                                                                                                                                                                                      |
|-------|-------------------------------|------|-------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-12 | X                             | X    | 0h    | Don't care                                                                                                                                                                                                                                                                       |
| 11-2  | DAC_DATA[9:0] / DAC_DATA[7:0] | W    | 000h  | Writing to the DAC_DATA register forces the respective DAC channel to update the active register data to the DAC_DATA. Data are in straight binary format and use the following format:<br>DACx3401-Q1: { DATA[9:0] }<br>DACx3401-Q1: { DATA[7:0], X, X }<br>X = Don't care bits |
| 1-0   | X                             | X    | 0h    | Don't care                                                                                                                                                                                                                                                                       |

### 8.6.5 DAC\_MARGIN\_HIGH Register (address = 25h) [reset = 0000h]

图 8-11. DAC\_MARGIN\_HIGH Register

| 15   | 14 | 13 | 12 | 11                                                     | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1    | 0 |
|------|----|----|----|--------------------------------------------------------|----|---|---|---|---|---|---|---|---|------|---|
| X    |    |    |    | MARGIN_HIGH[9:0] / MARGIN_HIGH[7:0] – MSB Left aligned |    |   |   |   |   |   |   |   |   | X    |   |
| X-0h |    |    |    | W-000h                                                 |    |   |   |   |   |   |   |   |   | X-0h |   |

表 8-19. DAC\_MARGIN\_HIGH Register Field Descriptions

| Bit   | Field                                                  | Type | Reset | Description                                                                                                                                                                                              |
|-------|--------------------------------------------------------|------|-------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-12 | X                                                      | X    | 0h    | Don't care                                                                                                                                                                                               |
| 11-2  | MARGIN_HIGH[9:0] / MARGIN_HIGH[7:0] – MSB Left aligned | W    | 000h  | Margin high code for DAC output. Data are in straight binary format and use the following format:<br>DACx3401-Q1: { MARGIN_HIGH[9:0] }<br>DACx3401-Q1: { MARGIN_HIGH[7:0], X, X }<br>X = Don't care bits |
| 1-0   | X                                                      | X    | 0h    | Don't care                                                                                                                                                                                               |

### 8.6.6 DAC\_MARGIN\_LOW Register (address = 26h) [reset = 0000h]

图 8-12. DAC\_MARGIN\_LOW Register

| 15   | 14 | 13 | 12 | 11                                                   | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1    | 0 |
|------|----|----|----|------------------------------------------------------|----|---|---|---|---|---|---|---|---|------|---|
| X    |    |    |    | MARGIN_LOW[9:0] / MARGIN_LOW[7:0] - MSB Left aligned |    |   |   |   |   |   |   |   |   | X    |   |
| X-0h |    |    |    | W-000h                                               |    |   |   |   |   |   |   |   |   | X-0h |   |

表 8-20. DAC\_MARGIN\_LOW Register Field Descriptions

| Bit   | Field                                                | Type | Reset | Description                                                                                                                                                                                              |
|-------|------------------------------------------------------|------|-------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-12 | X                                                    | X    | 0h    | Don't care                                                                                                                                                                                               |
| 11-2  | MARGIN_LOW[9:0] / MARGIN_LOW[7:0] - MSB Left aligned | W    | 000h  | Margin low code for DAC output.<br>Data are in straight binary format and follows the format below:<br>DACx3401-Q1: { MARGIN_LOW[9:0] }<br>DACx3401-Q1: { MARGIN_LOW[7:0], X, X }<br>X = Don't care bits |
| 1-0   | X                                                    | X    | 0h    | Don't care                                                                                                                                                                                               |

### 8.6.7 PMBUS\_OPERATION Register (address = 01h) [reset = 0000h]

图 8-13. PMBUS\_OPERATION Register

| 15                  | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7     | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|---------------------|----|----|----|----|----|---|---|-------|---|---|---|---|---|---|---|
| PMBUS_OPERATION_CMD |    |    |    |    |    |   |   | X     |   |   |   |   |   |   |   |
| R/ W-00h            |    |    |    |    |    |   |   | X-00h |   |   |   |   |   |   |   |

表 8-21. PMBUS\_OPERATION Register Field Descriptions

| Bit    | Field               | Type | Reset | Description                                                                                                                                                                                                          |
|--------|---------------------|------|-------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15 - 8 | PMBUS_OPERATION_CMD | R/W  | 00h   | PMBus operation commands<br>00h: Turn off<br>80h: Turn on<br>A4h: Margin high, DAC output margins high to MARGIN_HIGH code (address 25h)<br>94h: Margin low, DAC output margins low to MARGIN_LOW code (address 26h) |
| 7 - 0  | X                   | X    | 00h   | Not applicable                                                                                                                                                                                                       |

### 8.6.8 PMBUS\_STATUS\_BYTE Register (address = 78h) [reset = 0000h]

图 8-14. PMBUS\_STATUS\_BYTE Register

| 15    | 14 | 13 | 12 | 11     | 10 | 9 | 8 | 7      | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|-------|----|----|----|--------|----|---|---|--------|---|---|---|---|---|---|---|
| X     |    |    |    | CML    |    |   |   | X      |   |   |   |   |   |   |   |
| X-00h |    |    |    | R/W-0h |    |   |   | X-000h |   |   |   |   |   |   |   |

表 8-22. PMBUS\_STATUS\_BYTE Register Field Descriptions

| Bit     | Field | Type | Reset | Description                                                                                                                                                                        |
|---------|-------|------|-------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15 - 10 | X     | X    | 00h   | Don't care                                                                                                                                                                         |
| 9       | CML   | R/W  | 0     | 0: No communication Fault<br>1: PMBus communication fault for timeout, write with incorrect number of clocks, read before write command, and so more; reset this bit by writing 1. |
| 8 - 0   | X     | X    | 000h  | Not applicable                                                                                                                                                                     |

### 8.6.9 PMBUS\_VERSION Register (address = 98h) [reset = 2200h]

图 8-15. PMBUS\_VERSION Register

| 15            | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7     | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|---------------|----|----|----|----|----|---|---|-------|---|---|---|---|---|---|---|
| PMBUS_VERSION |    |    |    |    |    |   |   | X     |   |   |   |   |   |   |   |
| R-22h         |    |    |    |    |    |   |   | X-00h |   |   |   |   |   |   |   |

表 8-23. PMBUS\_VERSION Register Field Descriptions

| Bit    | Field         | Type | Reset | Description    |
|--------|---------------|------|-------|----------------|
| 15 - 8 | PMBUS_VERSION | R    | 22h   | PMBus version  |
| 7 - 0  | X             | X    | 00h   | Not applicable |

## 9 Application and Implementation

### Note

以下应用部分的信息不属于 TI 组件规范，TI 不担保其准确性和完整性。客户应负责确定 TI 组件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

### 9.1 Application Information

The DACx3401-Q1 are buffered, force-sense output, single-channel, DACs that include an NVM and internal reference and are available in a tiny 3 mm × 3 mm package. This device interfaces to a processor using I<sup>2</sup>C. There are 4 I<sup>2</sup>C addresses possible by configuring the A0 pin as shown in Table 7-5. The NVM allows processor-less operation of this device after programming at factory. The force-sense output can work with a transistor to create a programmable current sink that can bias LEDs. These digipots are designed for general-purpose applications in a wide range of end equipment. Some of the most common applications for these devices are power-supply margining and control, adaptive voltage scaling (AVS), *set-and-forget* LED biasing in automotive applications and mobile projectors, general-purpose function generation, and programmable comparator applications (such as standalone PWM control loops and offset and gain trimming in precision circuits).

### 9.2 Typical Applications

This section explains the design details of three primary applications of DACx3401-Q1: programmable LED biasing, and power-supply margining.

#### 9.2.1 Programmable LED Biasing

LED and laser biasing or driving circuits often require accuracy and stability of the luminosity with respect to variation in temperature, electrical conditions, and physical characteristics. This accuracy and stability are most effectively achieved using a precision DAC, such as the DACx3401-Q1. The DACx3401-Q1 have additional features, such as the V<sub>FB</sub> pin that compensates for the gate-to-source voltage of the transistor (V<sub>GS</sub>) drop and the drift of the MOSFET. The NVM allows the microprocessor to *set-and-forget* the LED biasing value, even during a power cycle. 图 9-1 shows the circuit diagram for LED biasing.

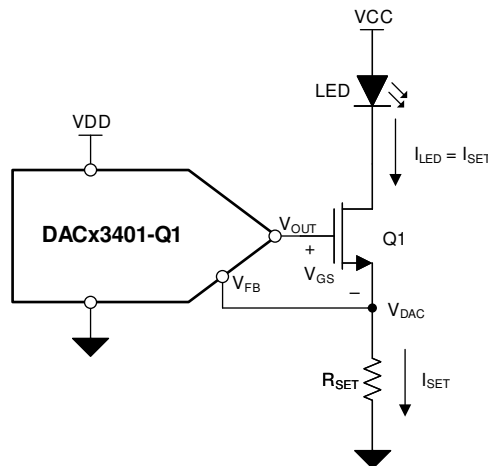


图 9-1. LED Biasing

##### 9.2.1.1 Design Requirements

- DAC output range: 0 V to 2.4 V
- LED current range: 0 mA to 20 mA

##### 9.2.1.2 Detailed Design Procedure

The DAC sets the source current of a MOSFET using the integrated buffer, as shown in 图 9-1. Connect the LED between the power supply and the drain of the MOSFET. This configuration allows the DAC to control or set the

amount of current through the LED. The integrated buffer controls the gate-source voltage of the MOSFET inside the feedback loop, thus compensating this drop and corresponding drift due to temperature, current, and ageing of the MOSFET. Calculate the value of the LED current set by the DAC using 方程式 6. In order to generate 0 mA to 20 mA from a 0-V to 2.4-V DAC output range, the value of  $R_{SET}$  resistor is  $120\text{-}\Omega$ . Select the internal reference with a span of 2x. Given a  $V_{GS}$  of 1.2 V, the  $V_{DD}$  of the DAC must be at least 3.6 V. Select a  $V_{DD}$  of 5 V to allow variation of  $V_{GS}$  across temperature. When the  $V_{DD}$  headroom is a constraint, use a bipolar junction transistor (BJT) in place of the MOSFET. BJTs have much less  $V_{BE}$  drop as compared to a  $V_{GS}$  of a MOSFET. A MOSFET provides a much better match between the current through the set register and the LED current, as compared to a BJT.

$$I_{SET} = \frac{V_{DAC}}{R_{SET}} \quad (6)$$

The pseudocode for getting started with an LED biasing application is as follows:

```
//SYNTAX: WRITE <REGISTER NAME (Hex code)>, <MSB DATA>, <LSB DATA>
//Power-up the device, enable internal reference with 2x output span
WRITE GENERAL_CONFIG(0xD1), 0x11, 0xE5
//Write DAC code (12-bit aligned)
WRITE DAC_DATA(0x21), 0x07, 0xFC
//Write settings to the NVM
WRITE TRIGGER(0xD3), 0x00, 0x10
```

### 9.2.1.3 Application Curves

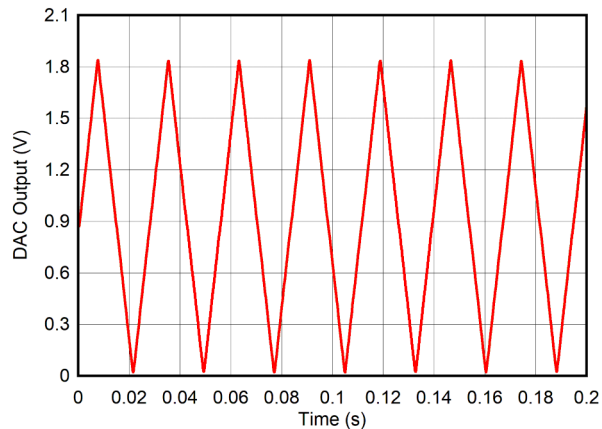


图 9-2. Triangular Waveform

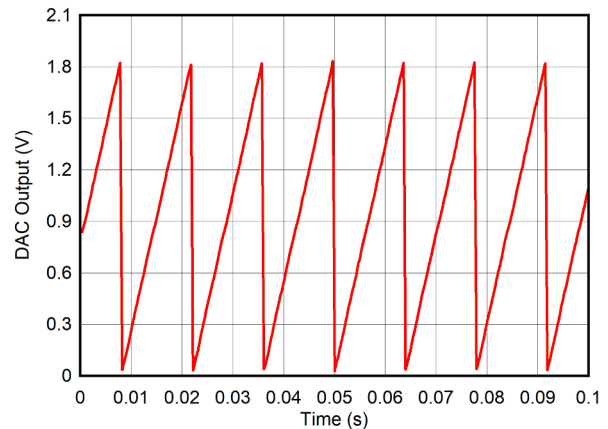


图 9-3. Sawtooth Waveform

## 9.2.2 Power-Supply Margining

A power-supply margining circuit is used to test and trim the output of a power converter. This circuit is used to test a system by margining the power supplies, for adaptive voltage scaling, or to program a desired value at the output. Adjustable power supplies, such as LDOs and DC/DC converters, provide a feedback or adjust input that is used to set the desired output. A precision voltage-output DAC is an excellent choice to control the power-supply output linearly. 图 9-4 shows a control circuit for a switch-mode power supply (SMPS) using the DACx3401-Q1. Typical applications include communications equipment, enterprise servers, test and measurement, automotive processor modules, and general-purpose power-supply modules.

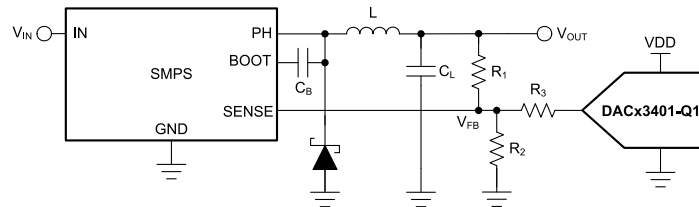


图 9-4. Power-Supply Margining

### 9.2.2.1 Design Requirements

- Power supply nominal output: 3.3 V
- Reference voltage of the converter ( $V_{FB}$ ): 0.6 V
- Margin:  $\pm 10\%$  (that is, 2.97 V to 3.63 V)
- DAC output range: 1.8 V
- Nominal current through  $R_1$  and  $R_2$ : 100  $\mu A$

### 9.2.2.2 Detailed Design Procedure

The DACx3401-Q1 features a Hi-Z power-down mode that is set by default at power-up, unless the device is programmed otherwise using NVM. When the DAC output is at Hi-Z, the current through  $R_3$  is zero and the SMPS is set at the nominal output voltage of 3.3 V. To have the same nominal condition when the DAC powers up, bring up the device at the same output as  $V_{FB}$  (that is, 0.6 V). This configuration makes sure there is no current through  $R_3$  even at power-up. Calculate  $R_1$  as  $(V_{OUT} - V_{FB}) / 100 \mu A = 27 k\Omega$ .

To achieve  $\pm 10\%$  margin-high and margin-low conditions, the DAC must sink or source additional current through  $R_1$ . Calculate the current from the DAC ( $I_{MARGIN}$ ) using 方程式 7 as 12  $\mu A$ .

$$I_{MARGIN} = \left( \frac{V_{OUT} \times (1 + MARGIN) - V_{FB}}{R_1} \right) - I_{NOMINAL} \quad (7)$$

where:

- $I_{MARGIN}$  is the margin current sourced or sinked from the DAC.
- MARGIN is the percentage margin value divided by 100.
- $I_{NOMINAL}$  is the nominal current through  $R_1$  and  $R_2$ .

To calculate the value of  $R_3$ , first decide the DAC output range; for safe operation in the linear region, avoid the codes near zero-scale and full-scale. A DAC output of 20 mV is a safe consideration as the minimum output, and  $(1.8 V - 0.6 V - 20 mV = 1.18 V)$  as the maximum output. When the DAC output is at 20 mV, the power supply goes to margin high, and when the DAC output is at 1.18 V, the power supply goes to margin low. Calculate the value of  $R_3$  using 方程式 8 as 48.3 k $\Omega$ . Choose a standard resistor value and adjust the DAC outputs. Choosing  $R_3 = 47 k\Omega$  gives the DAC margin high code as 1.164 V and the DAC margin low code as 36 mV.

$$R_3 = \frac{|V_{DAC} - V_{FB}|}{I_{MARGIN}} \quad (8)$$

The DACx3401-Q1 have a slew rate feature that is used to toggle between margin high, margin low, and nominal outputs with a defined slew rate. See [表 8-16](#) for the slew rate setting details.

### Note

The MARGIN HIGH register value in DACx3401-Q1 results in the MARGIN LOW value at the power supply output. Similarly, the MARGIN LOW register value in DACx3401-Q1 results in the MARGIN HIGH value at the power supply output.

The pseudocode for getting started with a power-supply control application is as follows:

```
//SYNTAX: WRITE <REGISTER NAME (Hex code)>, <MSB DATA>, <LSB DATA>
//Write DAC code (12-bit aligned) for nominal output
//For a 1.8-V output range, the 10-bit hex code for 0.6 V is 0x0155. With 12-bit alignment, it
becomes 0x0554
WRITE DAC_DATA(0x21), 0x05, 0x54
//Write DAC code (12-bit aligned) for margin-low output at the power supply
//For a 1.8-V output range, the 10-bit hex code for 1.164 V is 0x0296. With 12-bit alignment, it
becomes 0x0A58
WRITE DAC_MARGIN_HIGH(0x25), 0x0A, 0x58
//Write DAC code (12-bit aligned) for margin-high output at the power supply
//For a 1.8-V output range, the 10-bit hex code for 36 mV is 0x14. With 12-bit alignment, it
becomes 0x50
WRITE DAC_MARGIN_LOW(0x26), 0x00, 0x50
//Power-up the device with enable internal reference with 1.5x output span. This will output the
nominal voltage (0.6 V)
//CODE_STEP: 2 LSB, SLEW_RATE: 25.6  $\mu$ s
WRITE GENERAL_CONFIG(0xD1), 0x12, 0x14
//Trigger margin-low output at the power supply
WRITE TRIGGER(0xD3), 0x00, 0x80
//Trigger margin-high output at the power supply
WRITE TRIGGER(0xD3), 0x00, 0x40
//Write back DAC code (12-bit aligned) for nominal output
WRITE DAC_DATA(0x21), 0x05, 0x54
```

### 9.2.2.3 Application Curves

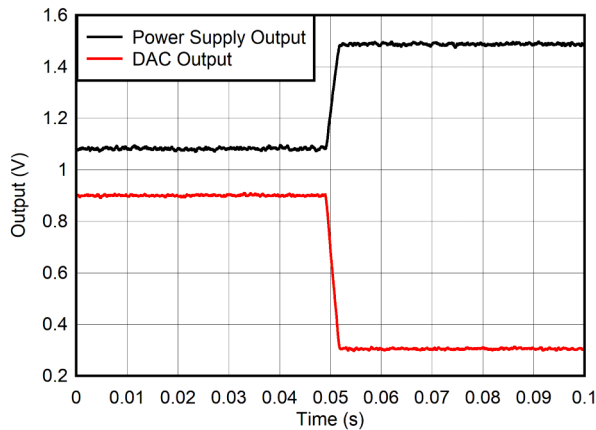


图 9-5. Power-Supply Margin High

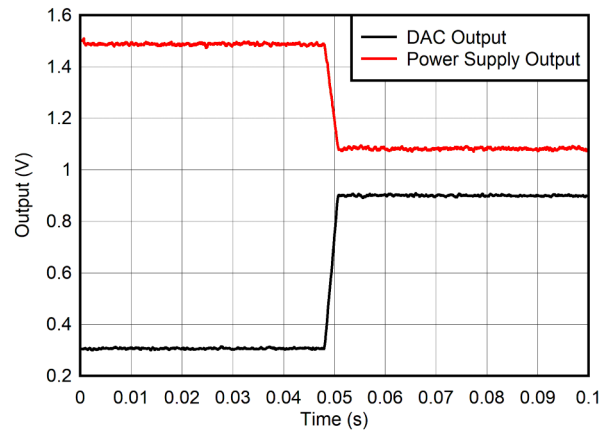


图 9-6. Power Supply Margin Low

## 10 Power Supply Recommendations

The DACx3401-Q1 family of devices does not require specific supply sequencing. These devices require a single power supply,  $V_{DD}$ . Use a 0.1- $\mu\text{F}$  decoupling capacitor for the  $V_{DD}$  pin. Use a bypass capacitor with a value around 1.5- $\mu\text{F}$  for the CAP pin.

## 11 Layout

### 11.1 Layout Guidelines

The DACx3401-Q1 pin configuration separates the analog, digital, and power pins for an optimized layout. For signal integrity, separate the digital and analog traces, and place decoupling capacitors close to the device pins.

### 11.2 Layout Example

图 11-1 shows an example layout drawing with decoupling capacitors and pullup resistors.

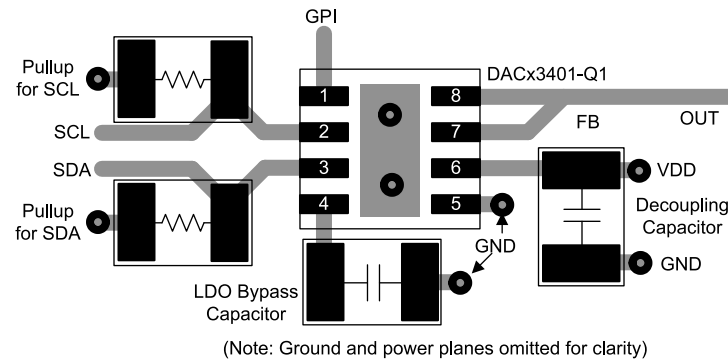


图 11-1. Layout Example

## 12 Device and Documentation Support

### 12.1 Documentation Support

#### 12.1.1 Related Documentation

For related documentation see the following:

Texas, Instruments [DAC53401EVM user's guide](#)

### 12.2 接收文档更新通知

要接收文档更新通知，请导航至 [ti.com](https://ti.com) 上的器件产品文件夹。点击 [订阅更新](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

### 12.3 支持资源

[TI E2E™ 支持论坛](#) 是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《[使用条款](#)》。

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### 12.6 术语表

[TI 术语表](#) 本术语表列出并解释了术语、首字母缩略词和定义。

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable part number          | Status<br>(1) | Material type<br>(2) | Package   Pins | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|--------------------------------|---------------|----------------------|----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">DAC43401DSGRQ1</a> | Active        | Production           | WSO (DSG)   8  | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | 44Q1                |
| DAC43401DSGRQ1.A               | Active        | Production           | WSO (DSG)   8  | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | 44Q1                |
| <a href="#">DAC43401DSGTQ1</a> | Active        | Production           | WSO (DSG)   8  | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | 44Q1                |
| DAC43401DSGTQ1.A               | Active        | Production           | WSO (DSG)   8  | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | 44Q1                |
| <a href="#">DAC53401DSGRQ1</a> | Active        | Production           | WSO (DSG)   8  | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | 54Q1                |
| DAC53401DSGRQ1.A               | Active        | Production           | WSO (DSG)   8  | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | 54Q1                |
| <a href="#">DAC53401DSGTQ1</a> | Active        | Production           | WSO (DSG)   8  | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | 54Q1                |
| DAC53401DSGTQ1.A               | Active        | Production           | WSO (DSG)   8  | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | 54Q1                |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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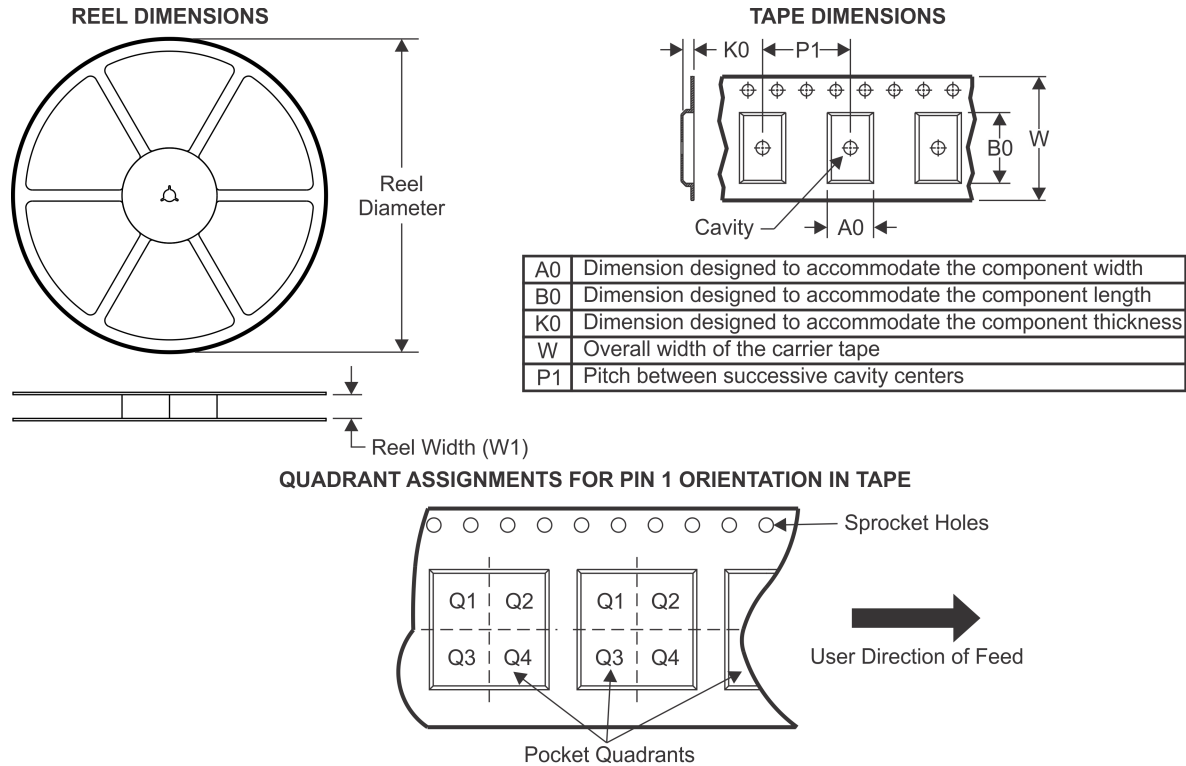
**OTHER QUALIFIED VERSIONS OF DAC43401-Q1, DAC53401-Q1 :**

- Catalog : [DAC43401](#), [DAC53401](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

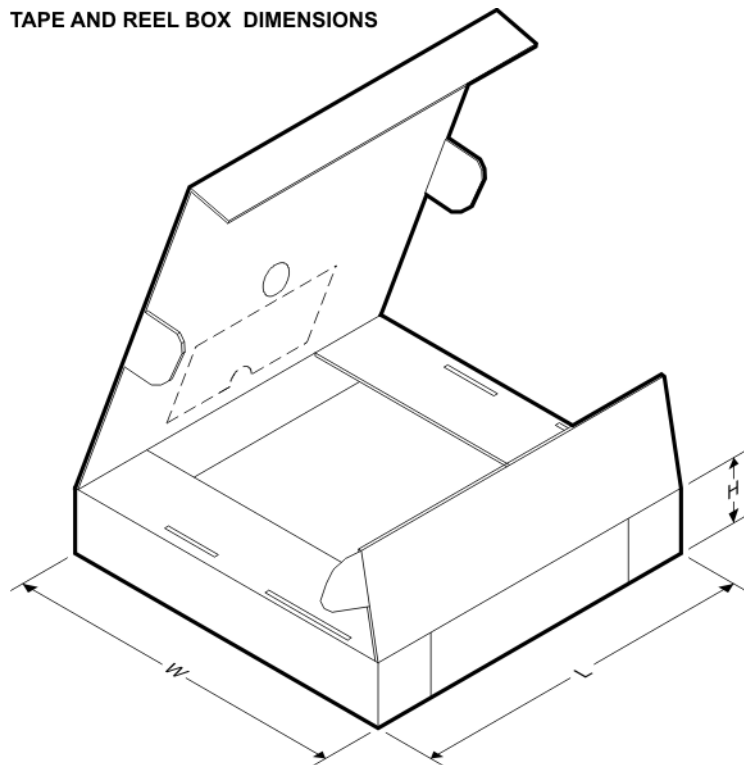
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

| Device         | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|----------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| DAC43401DSGRQ1 | WSO          | DSG             | 8    | 3000 | 180.0              | 8.4                | 2.3     | 2.3     | 1.15    | 4.0     | 8.0    | Q2            |
| DAC43401DSGTQ1 | WSO          | DSG             | 8    | 250  | 180.0              | 8.4                | 2.3     | 2.3     | 1.15    | 4.0     | 8.0    | Q2            |
| DAC53401DSGRQ1 | WSO          | DSG             | 8    | 3000 | 180.0              | 8.4                | 2.3     | 2.3     | 1.15    | 4.0     | 8.0    | Q2            |
| DAC53401DSGTQ1 | WSO          | DSG             | 8    | 250  | 180.0              | 8.4                | 2.3     | 2.3     | 1.15    | 4.0     | 8.0    | Q2            |

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device         | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|----------------|--------------|-----------------|------|------|-------------|------------|-------------|
| DAC43401DSGRQ1 | WSON         | DSG             | 8    | 3000 | 210.0       | 185.0      | 35.0        |
| DAC43401DSGTQ1 | WSON         | DSG             | 8    | 250  | 210.0       | 185.0      | 35.0        |
| DAC53401DSGRQ1 | WSON         | DSG             | 8    | 3000 | 210.0       | 185.0      | 35.0        |
| DAC53401DSGTQ1 | WSON         | DSG             | 8    | 250  | 210.0       | 185.0      | 35.0        |

## GENERIC PACKAGE VIEW

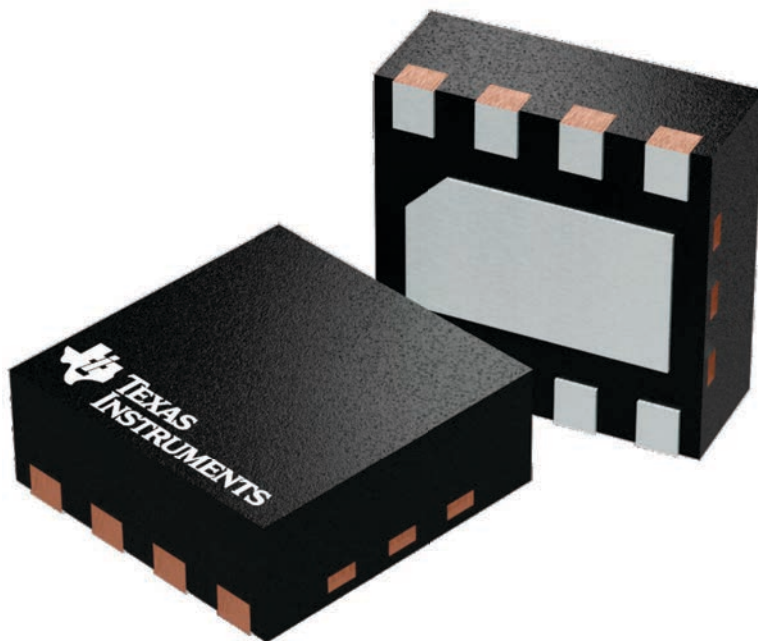
**DSG 8**

**WSON - 0.8 mm max height**

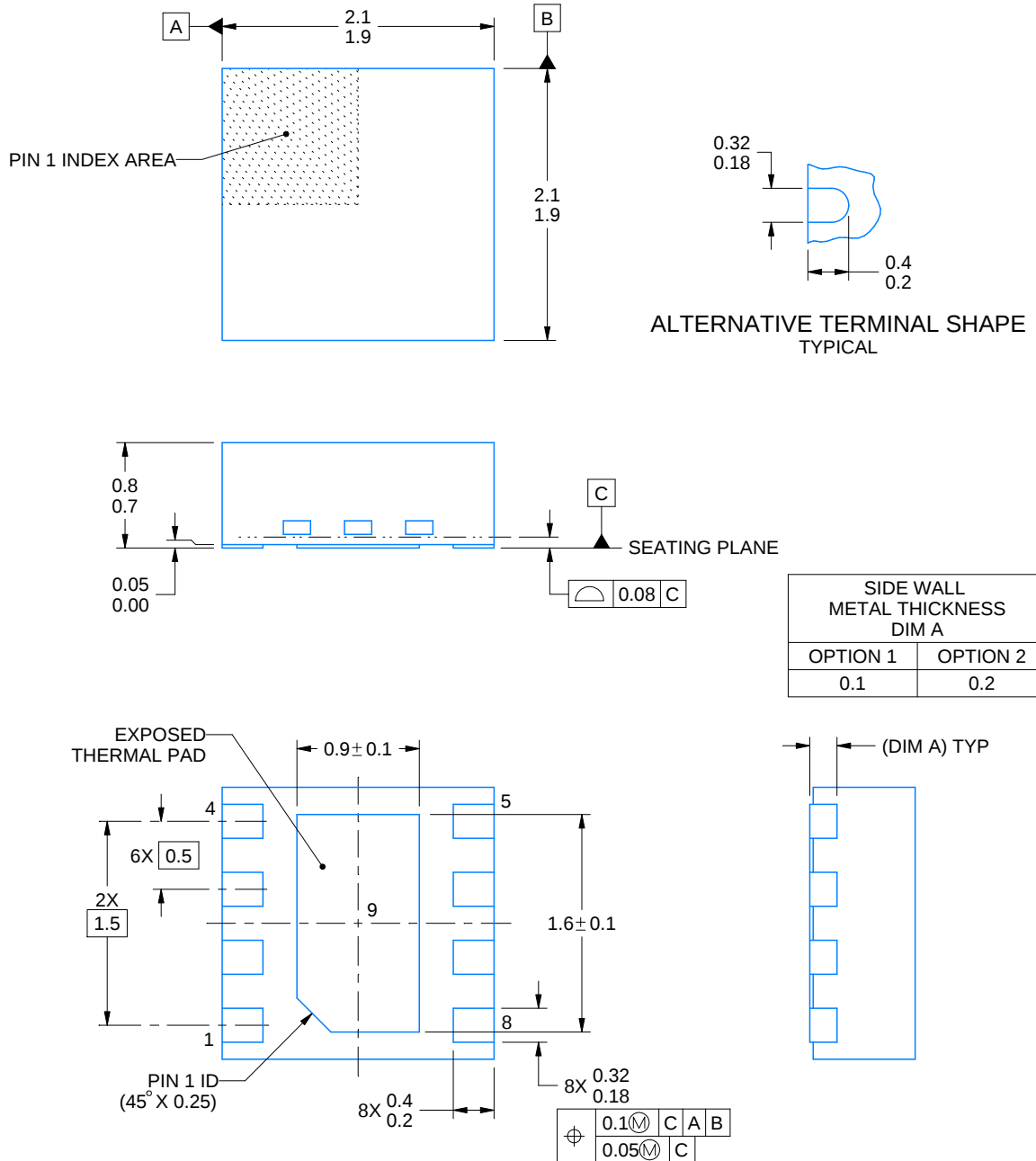
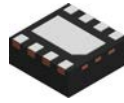
2 x 2, 0.5 mm pitch

PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.



4224783/A



4218900/E 08/2022

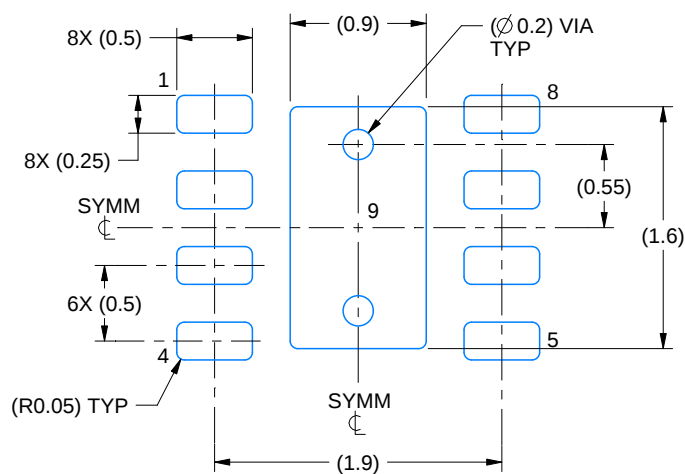
## NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

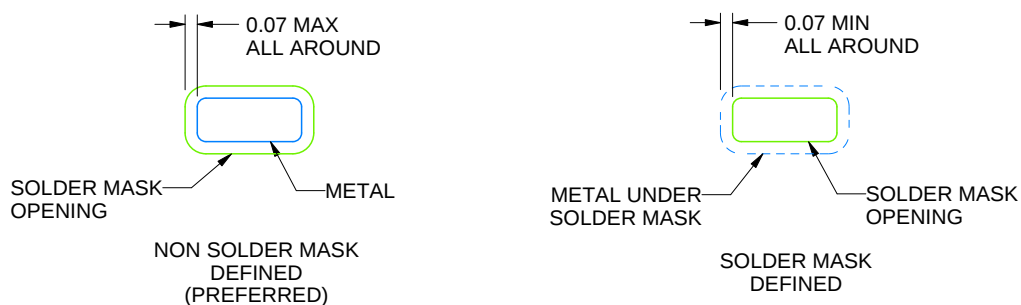
**DSG0008A**

**WSN - 0.8 mm max height**

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE  
SCALE:20X



## SOLDER MASK DETAILS

4218900/E 08/2022

NOTES: (continued)

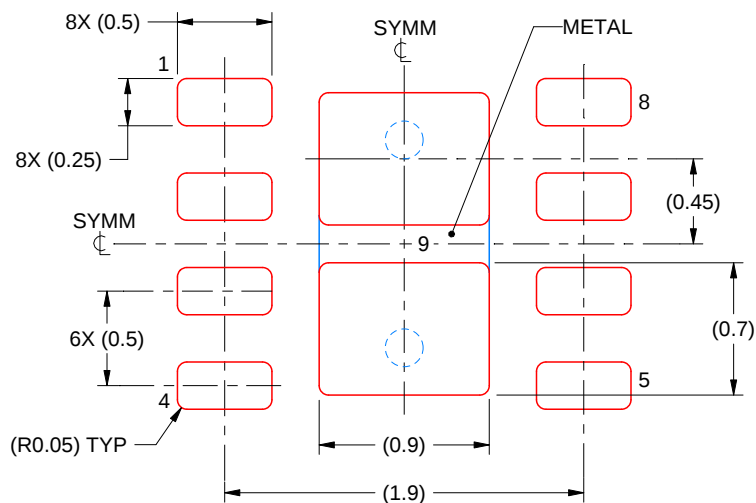
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/slua271](http://www.ti.com/lit/slua271)).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

## EXAMPLE STENCIL DESIGN

DSG0008A

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 9:  
87% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE  
SCALE:25X

4218900/E 08/2022

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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